

ISO674x General-Purpose Reinforced Quad-Channel Digital Isolators with Robust EMC

1 Features

- **Functional Safety-Capable**
 - Documentation available to aid functional safety system design: [ISO6740](#), [ISO6741](#), [ISO6742](#)
- 50 Mbps data rate
- Robust isolation barrier:
 - High lifetime at 1500 V_{RMS} working voltage
 - Up to 5000 V_{RMS} isolation rating
 - Up to 10 kV surge capability
 - ±150 kV/μs typical CMTI
- Wide supply range: 1.71 V to 1.89 V and 2.25 V to 5.5 V
- 1.71 V to 5.5 V level translation
- Default output *high* (ISO674x) and *low* (ISO674xF) options
- Wide temperature range: –40°C to 125°C
- 1.6 mA per channel typical at 1 Mbps
- Low propagation delay: 11 ns typical
- Robust electromagnetic compatibility (EMC)
 - System-level ESD, EFT, and surge immunity
 - ±8 kV IEC 61000-4-2 contact discharge protection across isolation barrier
 - Low emissions
- Wide-SOIC (DW-16) Package
- **Safety-Related Certifications** :
 - DIN VDE V 0884-11:2017-01
 - UL 1577 component recognition program
 - IEC 62368-1, IEC 61010-1, IEC 60601-1
 - GB 4943.1-2011 (pending)

2 Applications

- [Power supplies](#)
- [Grid, Electricity meter](#)
- [Motor drives](#)
- [Factory automation](#)
- [Building automation](#)
- [Lighting](#)
- [Appliances](#)

3 Description

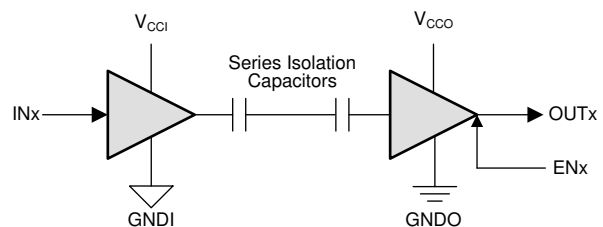
The ISO674x devices are high-performance, quad-channel digital isolators ideal for cost-sensitive applications requiring up to 5000 V_{RMS} isolation ratings per UL 1577. These devices are also certified by VDE, TUV, CSA, and CQC.

The ISO674x devices provide high electromagnetic immunity and low emissions at low power consumption, while isolating CMOS or LVC MOS digital I/Os. Each isolation channel has a logic input and output buffer separated by TI's double capacitive silicon dioxide (SiO₂) insulation barrier. These devices come with enable pins which can be used to put the respective outputs in high impedance for multi-master driving applications. The ISO6740 device has all four channels in the same direction, ISO6741 device has three forward and one reverse-direction channels, and ISO6742 device has two forward and two reverse-direction channels. In the event of input power or signal loss, the default output is *high* for devices without suffix F and *low* for devices with suffix F. See [Device Functional Modes](#) section for further details.

Device Information

PART NUMBER ⁽¹⁾	PACKAGE	BODY SIZE (NOM)
ISO6740, ISO6740F ISO6741, ISO6741F ISO6742, ISO6742F	SOIC (DW)	10.30 mm × 7.50 mm

- (1) For all available packages, see the orderable addendum at the end of the data sheet.



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V_{CCI}=Input supply, V_{CCO}=Output supply
GNDI=Input ground, GNDO=Output ground

Simplified Schematic



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4 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

Changes from Revision E (June 2021) to Revision F (May 2022)	Page
• Updated CMTI typical to 150 kV/us and minimum to 100 kV/us.....	7
Changes from Revision D (March 2021) to Revision E (June 2021)	Page
• Updated high lifetime working voltage.....	1
• Insulation Specifications table 7.6 has been updated with VIOWM 1500Vrms, VIORM at 2121Vpk.....	7
• Updated Safety-Related Certification table.....	7
• Updated switching characteristics tables with test conditions for "Default output delay time from input power loss" line item.....	7
• Switched the labels for V_{CC1} falling and V_{CC2} rising in the graph legend of <i>Power Supply Undervoltage Threshold vs Free-Air Temperature</i>	25
• Updated Typical Application diagram to reflect 5.5Viso.....	32
• Updated Insulation Lifetime Projection Data image.....	34
• Updated SN6505A reference with SN6505B in <i>Power Supply Recommendations</i>	36
Changes from Revision C (January 2021) to Revision D (March 2021)	Page
• Added ISO6742 data under Specifications.....	7
Changes from Revision B (December 2020) to Revision C (January 2021)	Page
• Added ISO674x to data sheet.....	1

Changes from Revision A (October 2020) to Revision B (December 2020)	Page
• Updated device status to Production Data.....	1

Changes from Revision * (August 2020) to Revision A (October 2020)	Page
• Pre-RTM adjustments.....	1

5 Description Continued

Used in conjunction with isolated power supplies, the ISO674x devices help prevent noise currents on data buses, such as UART, SPI, RS-485, RS-232, and CAN from damaging sensitive circuitry. Through innovative chip design and layout techniques, the electromagnetic compatibility of the ISO674x devices has been significantly enhanced to ease system-level ESD, EFT, surge, and emissions compliance. The ISO674x family of devices is available in a 16-pin SOIC wide-body (DW) package and is a pin-to-pin upgrade to the older generations.

6 Pin Configuration and Functions

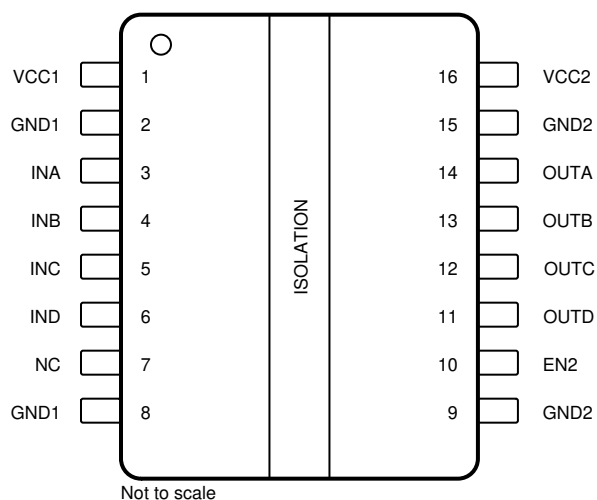


Figure 6-1. ISO6740 DW Package 16-Pin SOIC-WB Top View

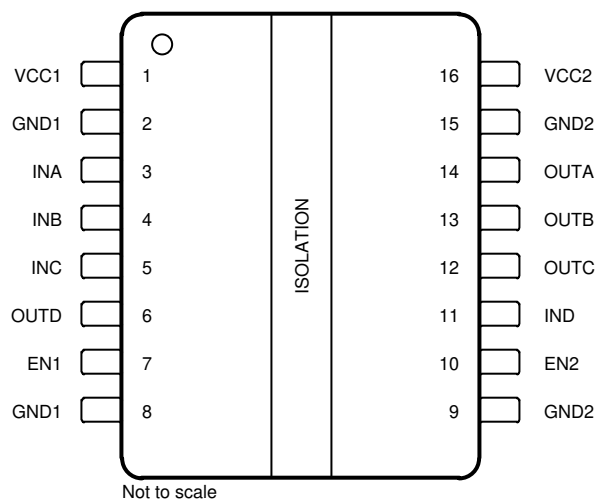


Figure 6-2. ISO6741 DW Package 16-Pin SOIC-WB Top View

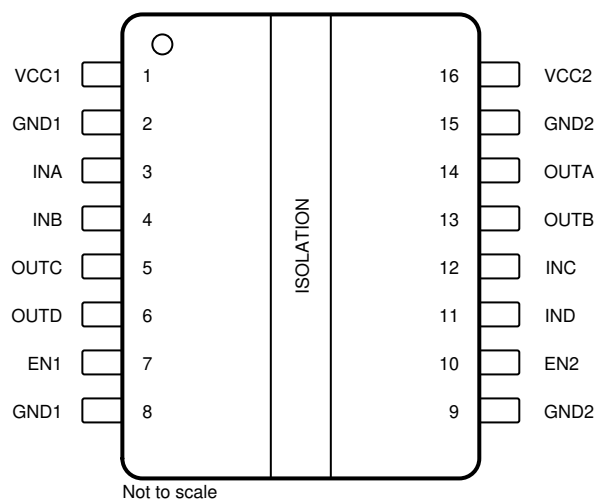


Figure 6-3. ISO6742 DW Package 16-Pin SOIC-WB Top View

Table 6-1. Pin Functions

NAME	PIN			I/O	DESCRIPTION
	ISO6740	ISO6741	ISO6742		
EN1	-	7	7	I	Output enable 1. Output pins on side 1 are enabled when EN1 is high or open and in high-impedance state when EN1 is low.
EN2	10	10	10	I	Output enable 2. Output pins on side 2 are enabled when EN2 is high or open and in high-impedance state when EN2 is low.
GND1	2, 8	2,8	2,8	—	Ground connection for V_{CC1}
GND2	9, 15	9,15	9,15	—	Ground connection for V_{CC2}
INA	3	3	3	I	Input, channel A
INB	4	4	4	I	Input, channel B
INC	5	5	12	I	Input, channel C
IND	6	11	11	I	Input, channel D
NC	7	-	-		Not connected
OUTA	14	14	14	O	Output, channel A
OUTB	13	13	13	O	Output, channel B
OUTC	12	12	5	O	Output, channel C
OUTD	11	6	6	O	Output, channel D
V_{CC1}	1	1	1	—	Power supply, side 1
V_{CC2}	16	16	16	—	Power supply, side 2

7 Specifications

Updated switching characteristics tables with test conditions for "Default output delay time from input power loss" line item

7.1 Absolute Maximum Ratings

See⁽¹⁾

		MIN	MAX	UNIT
Supply voltage ⁽²⁾	V _{CC1} to GND1	-0.5	6	V
	V _{CC2} to GND2	-0.5	6	
Input/Output Voltage	INx to GNDx	-0.5	V _{CCX} + 0.5 ⁽³⁾	V
	OUTx to GNDx	-0.5	V _{CCX} + 0.5 ⁽³⁾	
Output current	I _o	-15	15	mA
Temperature	Operating junction temperature, T _J		150	°C
	Storage temperature, T _{stg}	-65	150	°C

- (1) Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under Recommended Operating Conditions. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
- (2) All voltage values except differential I/O bus voltages are with respect to the local ground terminal (GND1 or GND2) and are peak voltage values
- (3) Maximum voltage must not exceed 6 V.

7.2 ESD Ratings

			VALUE	UNIT
V _(ESD)	Electrostatic discharge	Human body model (HBM), per ANSI/ESDA/JEDEC JS-001, all pins ⁽¹⁾	±6000	V
		Charged device model (CDM), per JEDEC specification JESD22-C101, all pins ⁽²⁾	±1500	
		Contact discharge per IEC 61000-4-2; Isolation barrier withstand test ^{(3) (4)}	±8000	

- (1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.
- (2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.
- (3) IEC ESD strike is applied across the barrier with all pins on each side tied together creating a two-terminal device.
- (4) Testing is carried out in air or oil to determine the intrinsic contact discharge capability of the device.

7.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

			MIN	NOM	MAX	UNIT
V_{CC1} ⁽¹⁾	Supply Voltage Side 1	$V_{CC} = 1.8 \text{ V}$ ⁽³⁾	1.71		1.89	V
V_{CC1} ⁽¹⁾	Supply Voltage Side 1	$V_{CC} = 2.5 \text{ V to } 5 \text{ V}$ ⁽³⁾	2.25		5.5	V
V_{CC2} ⁽¹⁾	Supply Voltage Side 2	$V_{CC} = 1.8 \text{ V}$ ⁽³⁾	1.71		1.89	V
V_{CC2} ⁽¹⁾	Supply Voltage Side 2	$V_{CC} = 2.5 \text{ V to } 5 \text{ V}$ ⁽³⁾	2.25		5.5	V
V_{CC} (UVLO+)	UVLO threshold when supply voltage is rising			1.53	1.71	V
V_{CC} (UVLO-)	UVLO threshold when supply voltage is falling		1.1	1.41		V
V_{hys} (UVLO)	Supply voltage UVLO hysteresis		0.08	0.13		V
V_{IH}	High level Input voltage		$0.7 \times V_{CCI}$ ⁽²⁾		V_{CCI}	V
V_{IL}	Low level Input voltage		0	$0.3 \times V_{CCI}$		V
I_{OH}	High level output current	$V_{CCO} = 5 \text{ V}$ ⁽²⁾	-4			mA
		$V_{CCO} = 3.3 \text{ V}$	-2			mA
		$V_{CCO} = 2.5 \text{ V}$	-1			mA
		$V_{CCO} = 1.8 \text{ V}$	-1			mA
I_{OL}	Low level output current	$V_{CCO} = 5 \text{ V}$			4	mA
		$V_{CCO} = 3.3 \text{ V}$			2	mA
		$V_{CCO} = 2.5 \text{ V}$			1	mA
		$V_{CCO} = 1.8 \text{ V}$			1	mA
DR	Data Rate		0		50	Mbps
T_A	Ambient temperature		-40	25	125	°C

(1) V_{CC1} and V_{CC2} can be set independent of one another

(2) $V_{CCI} = \text{Input-side } V_{CC}$; $V_{CCO} = \text{Output-side } V_{CC}$

(3) The channel outputs are in undetermined state when $1.89 \text{ V} < V_{CC1}$, $V_{CC2} < 2.25 \text{ V}$ and $1.05 \text{ V} < V_{CC1}$, $V_{CC2} < 1.71 \text{ V}$

7.4 Thermal Information

THERMAL METRIC ⁽¹⁾		ISO674x	UNIT
		DW (SOIC)	
		16 PINS	
$R_{\theta JA}$	Junction-to-ambient thermal resistance	73	°C/W
$R_{\theta JC(top)}$	Junction-to-case (top) thermal resistance	36.1	°C/W
$R_{\theta JB}$	Junction-to-board thermal resistance	40.4	°C/W
Ψ_{JT}	Junction-to-top characterization parameter	17	°C/W
Ψ_{JB}	Junction-to-board characterization parameter	39.9	°C/W
$R_{\theta JC(bot)}$	Junction-to-case (bottom) thermal resistance	—	°C/W

(1) For more information about traditional and new thermal metrics, see the [Semiconductor and IC Package Thermal Metrics](#) application report.

7.5 Power Ratings

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
ISO6740						
P _D	Maximum power dissipation (both sides)	V _{CC1} = V _{CC2} = 5.5 V, T _J = 150°C, C _L = 15 pF, Input a 25-MHz 50% duty cycle square wave			130.9	mW
P _{D1}	Maximum power dissipation (side-1)				33	mW
P _{D2}	Maximum power dissipation (side-2)				97.9	mW
ISO6741						
P _D	Maximum power dissipation (both sides)	V _{CC1} = V _{CC2} = 5.5 V, T _J = 150°C, C _L = 15 pF, Input a 25-MHz 50% duty cycle square wave			134.9	mW
P _{D1}	Maximum power dissipation (side-1)				50.8	mW
P _{D2}	Maximum power dissipation (side-2)				84.1	mW
ISO6742						
P _D	Maximum power dissipation (both sides)	V _{CC1} = V _{CC2} = 5.5 V, T _J = 150°C, C _L = 15 pF, Input a 25-MHz 50% duty cycle square wave			137.5	mW
P _{D1}	Maximum power dissipation (side-1)				68.75	mW
P _{D2}	Maximum power dissipation (side-2)				68.75	mW

7.6 Insulation Specifications

PARAMETER		TEST CONDITIONS	VALUE	UNIT
			DW-16	
CLR	External clearance ⁽¹⁾	Shortest terminal-to-terminal distance through air	>8	mm
CPG	External creepage ⁽¹⁾	Shortest terminal-to-terminal distance across the package surface	>8	mm
DTI	Distance through the insulation	Minimum internal gap (internal clearance)	>17	um
CTI	Comparative tracking index	DIN EN 60112 (VDE 0303-11); IEC 60112	>600	V
	Material group	According to IEC 60664-1	I	
	Overvoltage category per IEC 60664-1	Rated mains voltage ≤ 600 V _{RMS}	I-IV	
		Rated mains voltage ≤ 1000 V _{RMS}	I-III	
DIN VDE V 0884-11:2017-01 ⁽²⁾				
V _{IORM}	Maximum repetitive peak isolation voltage	AC voltage (bipolar)	2121	V _{PK}
V _{IOWM}	Maximum working isolation voltage	AC voltage; Time dependent dielectric breakdown (TDDb) Test; See Figure 10-8	1500	V _{RMS}
		DC voltage	2121	V _{DC}
V _{IOTM}	Maximum transient isolation voltage	V _{TEST} = V _{IOTM} , t = 60 s (qualification); V _{TEST} = 1.2 x V _{IOTM} , t= 1 s (100% production)	7071	V _{PK}
V _{IOSM}	Maximum surge isolation voltage ⁽³⁾	Test method per IEC 62368-1, 1.2/50 μs waveform, V _{TEST} = 1.6 x V _{IOSM} = 10,000 V _{PK} (qualification)	6250	V _{PK}
q _{pd}	Apparent charge ⁽⁴⁾	Method a, After Input-output safety test subgroup 2/3, V _{ini} = V _{IOTM} , t _{ini} = 60 s; V _{pd(m)} = 1.2 x V _{IORM} , t _m = 10 s	≤5	pC
		Method a, After environmental tests subgroup 1, V _{ini} = V _{IOTM} , t _{ini} = 60 s; V _{pd(m)} = 1.6 x V _{IORM} , t _m = 10 s	≤5	
		Method b; At routine test (100% production) and preconditioning (type test) V _{ini} = 1.2 x V _{IOTM} , t _{ini} = 1 s; V _{pd(m)} = 1.875 x V _{IORM} , t _m = 1 s	≤5	
C _{IO}	Barrier capacitance, input to output ⁽⁵⁾	V _{IO} = 0.4 x sin (2πft), f = 1 MHz	~1	pF
R _{IO}	Isolation resistance ⁽⁵⁾	V _{IO} = 500 V, T _A = 25°C	>10 ¹²	Ω
		V _{IO} = 500 V, 100°C ≤ T _A ≤ 125°C	>10 ¹¹	
		V _{IO} = 500 V at T _S = 150°C	>10 ⁹	
	Pollution degree		2	
	Climatic category		40/125/21	
UL 1577				
V _{ISO}	Maximum withstanding isolation voltage	V _{TEST} = V _{ISO} , t = 60 s (qualification), V _{TEST} = 1.2 x V _{ISO} , t = 1 s (100% production)	5000	V _{RMS}

- (1) Creepage and clearance requirements should be applied according to the specific equipment isolation standards of an application. Care should be taken to maintain the creepage and clearance distance of a board design to ensure that the mounting pads of the isolator on the printed-circuit board do not reduce this distance. Creepage and clearance on a printed-circuit board become equal in certain cases. Techniques such as inserting grooves and/or ribs on a printed-circuit board are used to help increase these specifications.
- (2) This coupler is suitable for *safe electrical insulation* only within the safety ratings. Compliance with the safety ratings shall be ensured by means of suitable protective circuits.
- (3) Testing is carried out in air or oil to determine the intrinsic surge immunity of the isolation barrier.
- (4) Apparent charge is electrical discharge caused by a partial discharge (pd).
- (5) All pins on each side of the barrier tied together creating a two-terminal device.

7.7 Safety-Related Certifications

VDE	CSA	UL	CQC	TUV
Certified according to DIN VDE V 0884-11:2017- 01	Certified according to IEC 62368-1, IEC 61010-1 and IEC 60601	Certified according to UL 1577 Component Recognition Program	Plan to certify according to GB4943.1-2011	Certified according to EN 61010-1:2010/ A1:2019 and EN 62368-1:2014
Maximum transient isolation voltage, 7071 V _{PK} ; Maximum repetitive peak isolation voltage, 2121 V _{PK} ; Maximum surge isolation voltage, 6250 V _{PK}	5000 V _{RMS} insulation per CSA 62368-1:19, IEC 62368-1:2018, CSA 61010-1-12+A1 and IEC 61010-1 3rd Ed., 1000 V _{RMS} basic and 600 V _{RMS} reinforced working voltage (pollution degree 2, material group I); 5000 V _{RMS} insulation per CSA 60601-1-14 and IEC 60601-1 Ed.3+A1, 2 MOPP for 250 V _{RMS}	Single protection, 5000 V _{RMS}	Reinforced insulation, Altitude ≤ 5000 m, Tropical Climate, 700 V _{RMS} maximum working voltage	5000 V _{RMS} reinforced insulation per EN 61010-1:2010/A1:2019 and EN 62368-1:2014 up to working voltage of 600 V _{RMS}
Certificate number: 40040142	Master contract number: 220991	File number: E181974	Certificate planned	Client ID number: 077311

7.8 Safety Limiting Values

Safety limiting⁽¹⁾ intends to minimize potential damage to the isolation barrier upon failure of input or output circuitry.

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
DW-16 PACKAGE						
I _S	Safety input, output, or supply current	R _{θJA} = 73°C/W, V _I = 5.5 V, T _J = 150°C, T _A = 25°C			311.4	mA
		R _{θJA} = 73°C/W, V _I = 3.6 V, T _J = 150°C, T _A = 25°C			475.7	mA
		R _{θJA} = 73°C/W, V _I = 2.75 V, T _J = 150°C, T _A = 25°C			622	
		R _{θJA} = 73°C/W, V _I = 1.89 V, T _J = 150°C, T _A = 25°C			905.1	mA
P _S	Safety input, output, or total power	R _{θJA} = 73°C/W, T _J = 150°C, T _A = 25°C			1712.4	mW
T _S	Maximum safety temperature				150	°C

- (1) The maximum safety temperature, T_S, has the same value as the maximum junction temperature, T_J, specified for the device. The I_S and P_S parameters represent the safety current and safety power respectively. The maximum limits of I_S and P_S should not be exceeded. These limits vary with the ambient temperature, T_A.
The junction-to-air thermal resistance, R_{θJA}, in the table is that of a device installed on a high-K test board for leaded surface-mount packages. Use these equations to calculate the value for each parameter:
T_J = T_A + R_{θJA} × P, where P is the power dissipated in the device.
T_{J(max)} = T_S = T_A + R_{θJA} × P_S, where T_{J(max)} is the maximum allowed junction temperature.
P_S = I_S × V_I, where V_I is the maximum input voltage.

Electrical Characteristics—5-V Supply

$V_{CC1} = V_{CC2} = 5\text{ V} \pm 10\%$ (over recommended operating conditions unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
V_{OH}	High-level output voltage	$I_{OH} = -4\text{ mA}$; See Figure 8-1	$V_{CCO} - 0.4$ ⁽¹⁾			V
V_{OL}	Low-level output voltage	$I_{OL} = 4\text{ mA}$; See Figure 8-1			0.4	V
$V_{IT+(IN)}$	Rising input switching threshold			$0.7 \times V_{CCI}$ ⁽¹⁾		V
$V_{IT-(IN)}$	Falling input switching threshold		$0.3 \times V_{CCI}$			V
$V_{I(HYS)}$	Input threshold voltage hysteresis		$0.1 \times V_{CCI}$			V
I_{IH}	High-level input current	$V_{IH} = V_{CCI}$ ⁽¹⁾ at INx			10	μA
I_{IL}	Low-level input current	$V_{IL} = 0\text{ V}$ at INx	-10			μA
I_{IH}	High-level input current	$V_{IH} = V_{CCI}$ ⁽¹⁾ at ENx			28	μA
I_{IL}	Low-level input current	$V_{IL} = 0\text{ V}$ at ENx	-28			μA
CMTI	Common mode transient immunity	$V_I = V_{CC}$ or 0 V , $V_{CM} = 1200\text{ V}$; See Figure 8-4	100	150		kV/ μs
C_i	Input Capacitance ⁽²⁾	$V_I = V_{CC}/2 + 0.4 \times \sin(2\pi ft)$, $f = 2\text{ MHz}$, $V_{CC} = 5\text{ V}$		2.8		pF

(1) V_{CCI} = Input-side V_{CC} ; V_{CCO} = Output-side V_{CC}

(2) Measured from input pin to same side ground.

7.9 Supply Current Characteristics—5-V Supply

$V_{CC1} = V_{CC2} = 5\text{ V} \pm 10\%$ (over recommended operating conditions unless otherwise noted)

PARAMETER	TEST CONDITIONS		SUPPLY CURRENT	MIN	TYP	MAX	UNIT
ISO6740							
Supply current - DC signal (2)	$V_I = V_{CC1}$ ⁽¹⁾ (ISO6740); $V_I = 0\text{ V}$ (ISO6740 with F suffix)		I_{CC1}		1.6	2.2	mA
			I_{CC2}		2.1	3.4	
	$V_I = 0\text{ V}$ (ISO6740); $V_I = V_{CC1}$ (ISO6740 with F suffix)		I_{CC1}		5.8	8	
			I_{CC2}		2.3	3.7	
Supply current - AC signal (3)	All channels switching with square wave clock input; $C_L = 15\text{ pF}$	1 Mbps	I_{CC1}		3.7	5.1	
			I_{CC2}		2.4	3.8	
		10 Mbps	I_{CC1}		3.8	5.3	
			I_{CC2}		4.8	6.4	
		50 Mbps	I_{CC1}		4.4	6	
			I_{CC2}		15	17.8	
ISO6741							
Supply current - DC signal (2)	$V_I = V_{CCI}$ ⁽¹⁾ (ISO6741); $V_I = 0\text{ V}$ (ISO6741 with F suffix)		I_{CC1}		1.9	2.8	mA
			I_{CC2}		2.2	3.5	
	$V_I = 0\text{ V}$ (ISO6741); $V_I = V_{CCI}$ (ISO6741 with F suffix)		I_{CC1}		5.1	7.2	
			I_{CC2}		3.4	5.1	
Supply current - AC signal (3)	All channels switching with square wave clock input; $C_L = 15\text{ pF}$	1 Mbps	I_{CC1}		3.6	5.1	
			I_{CC2}		3	4.5	
		10 Mbps	I_{CC1}		4.2	5.8	
			I_{CC2}		4.8	6.5	
		50 Mbps	I_{CC1}		7.3	9.3	
			I_{CC2}		12.6	15.3	
ISO6742							
Supply current - DC signal (2)	$V_I = V_{CCI}$ ⁽¹⁾ (ISO6742); $V_I = 0\text{ V}$ (ISO6742 with F suffix)		I_{CC1}, I_{CC2}		2.2	3.3	mA
	$V_I = 0\text{ V}$ (ISO6742); $V_I = V_{CCI}$ (ISO6742 with F suffix)		I_{CC1}, I_{CC2}		4.4	6.3	
Supply current - AC signal (3)	All channels switching with square wave clock input; $C_L = 15\text{ pF}$	1 Mbps	I_{CC1}, I_{CC2}		3.4	5	
		10 Mbps	I_{CC1}, I_{CC2}		4.7	6.4	
		50 Mbps	I_{CC1}, I_{CC2}		10.2	12.5	

(1) V_{CCI} = Input-side V_{CC}

(2) Supply current valid for $ENx = V_{CCx}$ and $ENx = 0\text{ V}$

(3) Supply current valid for $ENx = V_{CCx}$

7.10 Electrical Characteristics—3.3-V Supply

$V_{CC1} = V_{CC2} = 3.3 \text{ V} \pm 10\%$ (over recommended operating conditions unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
V_{OH}	High-level output voltage	$I_{OH} = -2\text{mA}$; See Figure 8-1	$V_{CCO} - 0.2$ ⁽¹⁾			V
V_{OL}	Low-level output voltage	$I_{OL} = 2\text{mA}$; See Figure 8-1	0.2			V
$V_{IT+(IN)}$	Rising input switching threshold		$0.7 \times V_{CCI}$ ⁽¹⁾			V
$V_{IT-(IN)}$	Falling input switching threshold		$0.3 \times V_{CCI}$			V
$V_{I(HYS)}$	Input threshold voltage hysteresis		$0.1 \times V_{CCI}$			V
I_{IH}	High-level input current	$V_{IH} = V_{CCI}$ ⁽¹⁾ at INx	10			μA
I_{IL}	Low-level input current	$V_{IL} = 0 \text{ V}$ at INx	-10			μA
I_{IH}	High-level input current	$V_{IH} = V_{CCI}$ ⁽¹⁾ at ENx	30			μA
I_{IL}	Low-level input current	$V_{IL} = 0 \text{ V}$ at ENx	-30			μA
CMTI	Common mode transient immunity	$V_I = V_{CC}$ or 0 V , $V_{CM} = 1200 \text{ V}$; See Figure 8-4	100	150		kV/us
C_i	Input Capacitance ⁽²⁾	$V_I = V_{CC}/2 + 0.4 \times \sin(2\pi f t)$, $f = 2 \text{ MHz}$, $V_{CC} = 3.3 \text{ V}$		2.8		pF

(1) V_{CCI} = Input-side V_{CC} ; V_{CCO} = Output-side V_{CC}

(2) Measured from input pin to same side ground.

7.11 Supply Current Characteristics—3.3-V Supply

$V_{CC1} = V_{CC2} = 3.3 \text{ V} \pm 10\%$ (over recommended operating conditions unless otherwise noted)

PARAMETER	TEST CONDITIONS		SUPPLY CURRENT	MIN	TYP	MAX	UNIT
ISO6740							
Supply current - DC signal ⁽²⁾	$V_I = V_{CC1}$ ⁽¹⁾ (ISO6740); $V_I = 0$ V (ISO6740 with F suffix)		I_{CC1}		1.6	2.2	mA
			I_{CC2}		2.1	3.3	
	$V_I = 0$ V (ISO6740); $V_I = V_{CC1}$ (ISO6740 with F suffix)		I_{CC1}		5.7	8	
			I_{CC2}		2.3	3.6	
Supply current - AC signal ⁽³⁾	All channels switching with square wave clock input; $C_L = 15$ pF	1 Mbps	I_{CC1}		3.7	5.1	
			I_{CC2}		2.4	3.7	
		10 Mbps	I_{CC1}		3.8	5.2	
			I_{CC2}		4	5.6	
		50 Mbps	I_{CC1}		4.2	5.7	
			I_{CC2}		11.2	13.8	
ISO6741							
Supply current - DC signal ⁽²⁾	$V_I = V_{CCI}$ ⁽¹⁾ (ISO6741); $V_I = 0$ V (ISO6741 with F suffix)		I_{CC1}		1.9	2.7	mA
			I_{CC2}		2.2	3.4	
	$V_I = 0$ V (ISO6741); $V_I = V_{CCI}$ (ISO6741 with F suffix)		I_{CC1}		5	7.1	
			I_{CC2}		3.4	5.1	
Supply current - AC signal ⁽³⁾	All channels switching with square wave clock input; $C_L = 15$ pF	1 Mbps	I_{CC1}		3.5	5	
			I_{CC2}		2.9	4.4	
		10 Mbps	I_{CC1}		4	5.5	
			I_{CC2}		4.2	5.8	
		50 Mbps	I_{CC1}		6.1	8	
			I_{CC2}		9.7	12.1	
ISO6742							
Supply current - DC signal ⁽²⁾	$V_I = V_{CCI}$ ⁽¹⁾ (ISO6742); $V_I = 0$ V (ISO6742 with F suffix)		I_{CC1} , I_{CC2}		2.2	3.3	mA
	$V_I = 0$ V (ISO6742); $V_I = V_{CCI}$ (ISO6742 with F suffix)		I_{CC1} , I_{CC2}		4.4	6.3	
Supply current - AC signal ⁽³⁾	All channels switching with square wave clock input; $C_L = 15$ pF	1 Mbps	I_{CC1} , I_{CC2}		3.4	4.9	
		10 Mbps	I_{CC1} , I_{CC2}		4.2	5.9	
		50 Mbps	I_{CC1} , I_{CC2}		8.2	10.3	

(1) V_{CCI} = Input-side V_{CC}

(2) Supply current valid for $ENx = V_{CCx}$ and $ENx = 0 \text{ V}$

(3) Supply current valid for $ENx = V_{CCx}$

7.12 Electrical Characteristics—2.5-V Supply

$V_{CC1} = V_{CC2} = 2.5 \text{ V} \pm 10\%$ (over recommended operating conditions unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
V_{OH}	High-level output voltage	$I_{OH} = -1\text{mA}$; See Figure 8-1	$V_{CCO} - 0.1$ ⁽¹⁾			V
V_{OL}	Low-level output voltage	$I_{OL} = 1\text{mA}$; See Figure 8-1	0.1			V
$V_{IT+(IN)}$	Rising input switching threshold		$0.7 \times V_{CCI}$ ⁽¹⁾			V
$V_{IT-(IN)}$	Falling input switching threshold		$0.3 \times V_{CCI}$			V
$V_{I(HYS)}$	Input threshold voltage hysteresis		$0.1 \times V_{CCI}$			V
I_{IH}	High-level input current	$V_{IH} = V_{CCI}$ ⁽¹⁾ at INx	10			μA
I_{IL}	Low-level input current	$V_{IL} = 0 \text{ V}$ at INx	-10			μA
I_{IH}	High-level input current	$V_{IH} = V_{CCI}$ ⁽¹⁾ at ENx	30			μA
I_{IL}	Low-level input current	$V_{IL} = 0 \text{ V}$ at ENx	-30			μA
CMTI	Common mode transient immunity	$V_I = V_{CC}$ or 0 V , $V_{CM} = 1200 \text{ V}$; See Figure 8-4	100	150		kV/us
C_i	Input Capacitance ⁽²⁾	$V_I = V_{CC}/2 + 0.4 \times \sin(2\pi f t)$, $f = 2 \text{ MHz}$, $V_{CC} = 2.5 \text{ V}$		2.8		pF

(1) V_{CCI} = Input-side V_{CC} ; V_{CCO} = Output-side V_{CC}

(2) Measured from input pin to same side ground.

7.13 Supply Current Characteristics—2.5-V Supply

$V_{CC1} = V_{CC2} = 2.5 \text{ V} \pm 10\%$ (over recommended operating conditions unless otherwise noted)

PARAMETER	TEST CONDITIONS		SUPPLY CURRENT	MIN	TYP	MAX	UNIT
ISO6740							
Supply current - DC signal (2)	$V_I = V_{CC1}$ ⁽¹⁾ (ISO6740); $V_I = 0$ V (ISO6740 with F suffix)		I_{CC1}		1.6	2.2	mA
			I_{CC2}		2.1	3.3	
	$V_I = 0$ V (ISO6740); $V_I = V_{CC1}$ (ISO6740 with F suffix)		I_{CC1}		5.7	7.9	
			I_{CC2}		2.3	3.6	
Supply current - AC signal ⁽³⁾	All channels switching with square wave clock input; $C_L = 15$ pF	1 Mbps	I_{CC1}		3.7	5.1	
			I_{CC2}		2.3	3.6	
		10 Mbps	I_{CC1}		3.7	5.1	
			I_{CC2}		3.5	5.1	
		50 Mbps	I_{CC1}		4.1	5.6	
			I_{CC2}		9	11.2	
ISO6741							
Supply current - DC signal (2)	$V_I = V_{CCI}$ ⁽¹⁾ (ISO6741); $V_I = 0$ V (ISO6741 with F suffix)		I_{CC1}		1.9	2.7	mA
			I_{CC2}		2.2	3.4	
	$V_I = 0$ V (ISO6741); $V_I = V_{CCI}$ (ISO6741 with F suffix)		I_{CC1}		5	7.1	
			I_{CC2}		3.4	5.1	
Supply current - AC signal (3)	All channels switching with square wave clock input; $C_L = 15$ pF	1 Mbps	I_{CC1}		3.5	5	
			I_{CC2}		2.9	4.4	
		10 Mbps	I_{CC1}		3.9	5.4	
			I_{CC2}		3.8	5.4	
		50 Mbps	I_{CC1}		5.5	7.2	
			I_{CC2}		8.1	10.2	
ISO6742							
Supply current - DC signal (2)	$V_I = V_{CCI}$ ⁽¹⁾ (ISO6742); $V_I = 0$ V (ISO6742 with F suffix)		I_{CC1} , I_{CC2}		2.2	3.3	mA
	$V_I = 0$ V (ISO6742); $V_I = V_{CCI}$ (ISO6742 with F suffix)		I_{CC1} , I_{CC2}		4.3	6.3	
Supply current - AC signal ⁽³⁾	All channels switching with square wave clock input; $C_L = 15$ pF	1 Mbps	I_{CC1} , I_{CC2}		3.3	4.8	
		10 Mbps	I_{CC1} , I_{CC2}		4	5.6	
		50 Mbps	I_{CC1} , I_{CC2}		7	9	

(1) V_{CCI} = Input-side V_{CC}

(2) Supply current valid for $ENx = V_{CCx}$ and $ENx = 0 \text{ V}$

(3) Supply current valid for $ENx = V_{CCx}$

Electrical Characteristics—1.8-V Supply

$V_{CC1} = V_{CC2} = 1.8 \text{ V} \pm 5\%$ (over recommended operating conditions unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
V_{OH}	High-level output voltage	$I_{OH} = -1 \text{ mA}$; See Figure 8-1	$V_{CCO} - 0.1$ ⁽¹⁾			V
V_{OL}	Low-level output voltage	$I_{OL} = 1 \text{ mA}$; See Figure 8-1			0.1	V
$V_{IT+(IN)}$	Rising input switching threshold			$0.7 \times V_{CCI}$ ⁽¹⁾		V
$V_{IT-(IN)}$	Falling input switching threshold		$0.3 \times V_{CCI}$			V
$V_{I(HYS)}$	Input threshold voltage hysteresis		$0.1 \times V_{CCI}$			V
I_{IH}	High-level input current	$V_{IH} = V_{CCI}$ ⁽¹⁾ at INx			10	μA
I_{IL}	Low-level input current	$V_{IL} = 0 \text{ V}$ at INx	-10			μA
I_{IH}	High-level input current	$V_{IH} = V_{CCI}$ ⁽¹⁾ at ENx			30	μA
I_{IL}	Low-level input current	$V_{IL} = 0 \text{ V}$ at ENx	-30			μA
CMTI	Common mode transient immunity	$V_I = V_{CC}$ or 0 V , $V_{CM} = 1200 \text{ V}$; See Figure 8-4	100	150		kV/us
C_i	Input Capacitance ⁽²⁾	$V_I = V_{CC}/2 + 0.4 \times \sin(2\pi f t)$, $f = 2 \text{ MHz}$, $V_{CC} = 1.8 \text{ V}$		2.8		pF

(1) V_{CCI} = Input-side V_{CC} ; V_{CCO} = Output-side V_{CC}

(2) Measured from input pin to same side ground.

7.14 Supply Current Characteristics—1.8-V Supply

$V_{CC1} = V_{CC2} = 1.8 \text{ V} \pm 5\%$ (over recommended operating conditions unless otherwise noted)

PARAMETER	TEST CONDITIONS		SUPPLY CURRENT	MIN	TYP	MAX	UNIT
ISO6740							
Supply current - DC signal ⁽²⁾	$V_I = V_{CC1}$ ⁽¹⁾ (ISO6740); $V_I = 0$ V (ISO6740 with F suffix)		I_{CC1}		1.2	1.8	mA
			I_{CC2}		2	3.4	
	$V_I = 0$ V (ISO6740); $V_I = V_{CC1}$ (ISO6740 with F suffix)		I_{CC1}		5.1	7.6	
			I_{CC2}		2.2	3.7	
Supply current - AC signal ⁽³⁾	All channels switching with square wave clock input; $C_L = 15$ pF	1 Mbps	I_{CC1}		3.1	4.7	
			I_{CC2}		2.2	3.7	
		10 Mbps	I_{CC1}		3.2	4.8	
			I_{CC2}		3.1	4.6	
		50 Mbps	I_{CC1}		3.4	5.1	
			I_{CC2}		7	8.9	
ISO6741							
Supply current - DC signal ⁽²⁾	$V_I = V_{CCI}$ ⁽¹⁾ (ISO6741); $V_I = 0$ V (ISO6741 with F suffix)		I_{CC1}		1.5	2.4	mA
			I_{CC2}		2	3.4	
	$V_I = 0$ V (ISO6741); $V_I = V_{CCI}$ (ISO6741 with F suffix)		I_{CC1}		4.5	6.9	
			I_{CC2}		3.2	5	
Supply current - AC signal ⁽³⁾	All channels switching with square wave clock input; $C_L = 15$ pF	1 Mbps	I_{CC1}		3.1	4.7	
			I_{CC2}		2.7	4.3	
		10 Mbps	I_{CC1}		3.3	5	
			I_{CC2}		3.4	5	
		50 Mbps	I_{CC1}		4.5	6.3	
			I_{CC2}		6.4	8.3	
ISO6742							
Supply current - DC signal ⁽²⁾	$V_I = V_{CCI}$ ⁽¹⁾ (ISO6742); $V_I = 0$ V (ISO6742 with F suffix)		I_{CC1} , I_{CC2}		1.9	3.1	mA
	$V_I = 0$ V (ISO6742); $V_I = V_{CCI}$ (ISO6742 with F suffix)		I_{CC1} , I_{CC2}		4	6.1	
Supply current - AC signal ⁽³⁾	All channels switching with square wave clock input; $C_L = 15$ pF	1 Mbps	I_{CC1} , I_{CC2}		3	4.7	
		10 Mbps	I_{CC1} , I_{CC2}		3.5	5.2	
		50 Mbps	I_{CC1} , I_{CC2}		5.6	7.6	

(1) V_{CCI} = Input-side V_{CC}

(2) Supply current valid for $ENx = V_{CCx}$ and $ENx = 0 \text{ V}$

(3) Supply current valid for $ENx = V_{CCx}$

7.15 Switching Characteristics—5-V Supply

$V_{CC1} = V_{CC2} = 5\text{ V} \pm 10\%$ (over recommended operating conditions unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
t_{PLH} , t_{PHL}	Propagation delay time	@100kbps See Figure 8-1		11	18	ns
PWD	Pulse width distortion ⁽¹⁾ $ t_{PHL} - t_{PLH} $			0.2	7	ns
$t_{sk(o)}$	Channel-to-channel output skew time ⁽²⁾	Same-direction channels			6	ns
$t_{sk(pp)}$	Part-to-part skew time ⁽³⁾				6	ns
t_r	Output signal rise time	See Figure 8-1		2.6	4.5	ns
t_f	Output signal fall time			2.6	4.5	ns
t_{PHZ}	Disable propagation delay, high-to-high impedance output	See Figure 8-2		18.6	25.8	ns
t_{PLZ}	Disable propagation delay, low-to-high impedance output			18.6	25.8	ns
t_{PZH}	Enable propagation delay, high impedance-to-high output for ISO674x			14.2	21.1	ns
t_{PZL}	Enable propagation delay, high impedance-to-low output for ISO674x			14.2	21.1	ns
t_{PU}	Time from UVLO to valid output data				300	us
t_{DO}	Default output delay time from input power loss	Measured from the time VCC goes below 1.2V. See Figure 8-3		0.1	0.3	us
t_{ie}	Time interval error	$2^{16} - 1$ PRBS data at 50 Mbps		1		ns

(1) Also known as pulse skew.

(2) $t_{sk(o)}$ is the skew between outputs of a single device with all driving inputs connected together and the outputs switching in the same direction while driving identical loads.

(3) $t_{sk(pp)}$ is the magnitude of the difference in propagation delay times between any terminals of different devices switching in the same direction while operating at identical supply voltages, temperature, input signals and loads.

7.16 Switching Characteristics—3.3-V Supply

$V_{CC1} = V_{CC2} = 3.3\text{ V} \pm 10\%$ (over recommended operating conditions unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
t_{PLH}, t_{PHL}	Propagation delay time	@100kbps See Figure 8-1		11	18	ns
PWD	Pulse width distortion ⁽¹⁾ $ t_{PHL} - t_{PLH} $			0.5	7	ns
$t_{sk(o)}$	Channel-to-channel output skew time ⁽²⁾	Same-direction channels			6	ns
$t_{sk(pp)}$	Part-to-part skew time ⁽³⁾				7	ns
t_r	Output signal rise time	See Figure 8-1		1.6	3.2	ns
t_f	Output signal fall time			1.6	3.2	ns
t_{PHZ}	Disable propagation delay, high-to-high impedance output	See Figure 8-2		23.2	34.4	ns
t_{PLZ}	Disable propagation delay, low-to-high impedance output			23.2	34.4	ns
t_{PZH}	Enable propagation delay, high impedance-to-high output for ISO674x			16.6	23	ns
t_{PZL}	Enable propagation delay, high impedance-to-low output for ISO674x			16.6	23	ns
t_{PU}	Time from UVLO to valid output data				300	us
t_{DO}	Default output delay time from input power loss	Measured from the time VCC goes below 1.2V. See Figure 8-3		0.1	0.3	us
t_{ie}	Time interval error	$2^{16} - 1$ PRBS data at 50 Mbps		1		ns

- (1) Also known as pulse skew.
- (2) $t_{sk(o)}$ is the skew between outputs of a single device with all driving inputs connected together and the outputs switching in the same direction while driving identical loads.
- (3) $t_{sk(pp)}$ is the magnitude of the difference in propagation delay times between any terminals of different devices switching in the same direction while operating at identical supply voltages, temperature, input signals and loads.

7.17 Switching Characteristics—2.5-V Supply

$V_{CC1} = V_{CC2} = 2.5\text{ V} \pm 10\%$ (over recommended operating conditions unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
t_{PLH} , t_{PHL}	Propagation delay time	@100kbps See Figure 8-1		12	20.5	ns
PWD	Pulse width distortion ⁽¹⁾ $ t_{PHL} - t_{PLH} $			0.6	7.1	ns
$t_{sk(o)}$	Channel-to-channel output skew time ⁽²⁾	Same-direction channels			6	ns
$t_{sk(pp)}$	Part-to-part skew time ⁽³⁾				7	ns
t_r	Output signal rise time	See Figure 8-1		2	4	ns
t_f	Output signal fall time			2	4	ns
t_{PHZ}	Disable propagation delay, high-to-high impedance output	See Figure 8-2		28.1	43	ns
t_{PLZ}	Disable propagation delay, low-to-high impedance output			28.1	43	ns
t_{PZH}	Enable propagation delay, high impedance-to-high output for ISO674x			20.4	36.3	ns
t_{PZL}	Enable propagation delay, high impedance-to-low output for ISO674x			20.4	36.3	ns
t_{PU}	Time from UVLO to valid output data				300	us
t_{DO}	Default output delay time from input power loss	Measured from the time VCC goes below 1.2V. See Figure 8-3		0.1	0.3	us
t_{ie}	Time interval error	$2^{16} - 1$ PRBS data at 50 Mbps		1		ns

(1) Also known as pulse skew.

(2) $t_{sk(o)}$ is the skew between outputs of a single device with all driving inputs connected together and the outputs switching in the same direction while driving identical loads.

(3) $t_{sk(pp)}$ is the magnitude of the difference in propagation delay times between any terminals of different devices switching in the same direction while operating at identical supply voltages, temperature, input signals and loads.

7.18 Switching Characteristics—1.8-V Supply

 $V_{CC1} = V_{CC2} = 1.8\text{ V} \pm 5\%$ (over recommended operating conditions unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
t_{PLH}, t_{PHL}	Propagation delay time	@100kbps See Figure 8-1		15	24	ns
PWD	Pulse width distortion ⁽¹⁾ $ t_{PHL} - t_{PLH} $			0.7	8.2	ns
$t_{sk(o)}$	Channel-to-channel output skew time ⁽²⁾	Same-direction channels			6	ns
$t_{sk(pp)}$	Part-to-part skew time ⁽³⁾				8.8	ns
t_r	Output signal rise time	See Figure 8-1		2.7	5.3	ns
t_f	Output signal fall time			2.7	5.3	ns
t_{PHZ}	Disable propagation delay, high-to-high impedance output	See Figure 8-2		40.3	63	ns
t_{PLZ}	Disable propagation delay, low-to-high impedance output			40.3	63	ns
t_{PZH}	Enable propagation delay, high impedance-to-high output for ISO674x			30	51.4	ns
t_{PZL}	Enable propagation delay, high impedance-to-low output for ISO674x			30	51.4	ns
t_{PU}	Time from UVLO to valid output data				300	us
t_{DO}	Default output delay time from input power loss	Measured from the time VCC goes below 1.2V. See Figure 8-3		0.1	0.3	us
t_{ie}	Time interval error	$2^{16} - 1$ PRBS data at 50 Mbps		1		ns

(1) Also known as pulse skew.

(2) $t_{sk(o)}$ is the skew between outputs of a single device with all driving inputs connected together and the outputs switching in the same direction while driving identical loads.

(3) $t_{sk(pp)}$ is the magnitude of the difference in propagation delay times between any terminals of different devices switching in the same direction while operating at identical supply voltages, temperature, input signals and loads.

7.19 Insulation Characteristics Curves

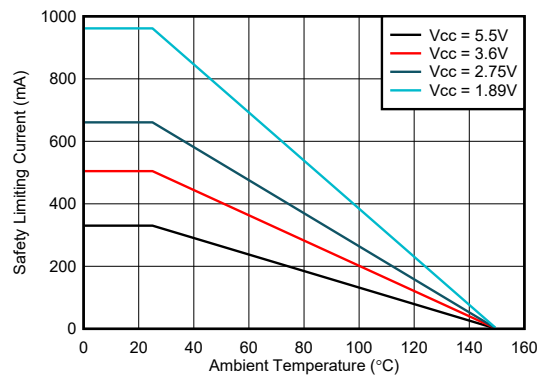


Figure 7-1. Thermal Derating Curve for Safety Limiting Current for DW-16 Package

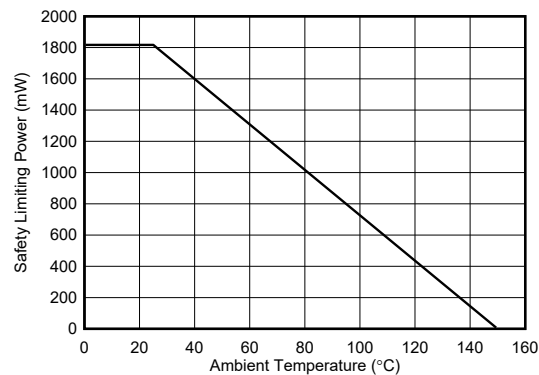


Figure 7-2. Thermal Derating Curve for Safety Limiting Power for DW-16 Package

7.20 Typical Characteristics

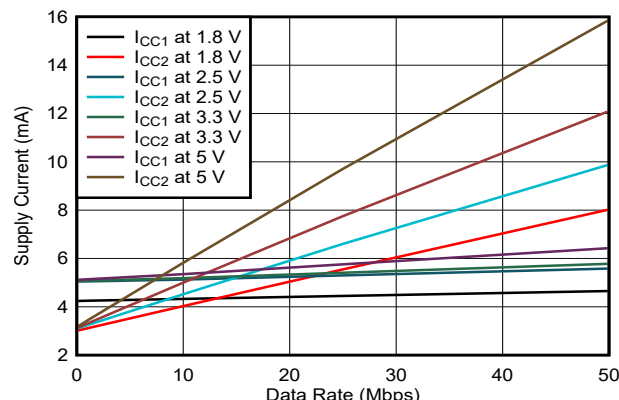


Figure 7-3. ISO6760 Supply Current vs Data Rate (With 15-pF Load)

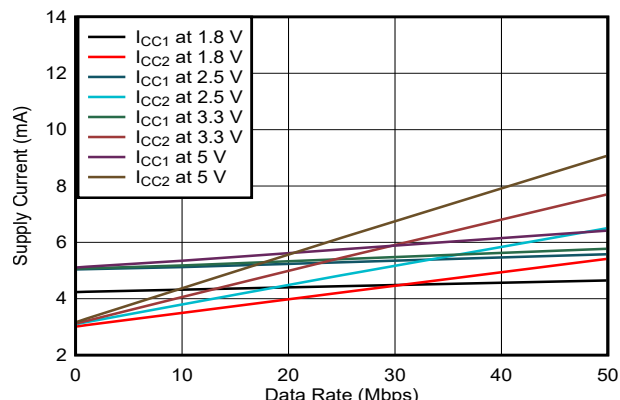


Figure 7-4. ISO6760 Supply Current vs Data Rate (With No Load)

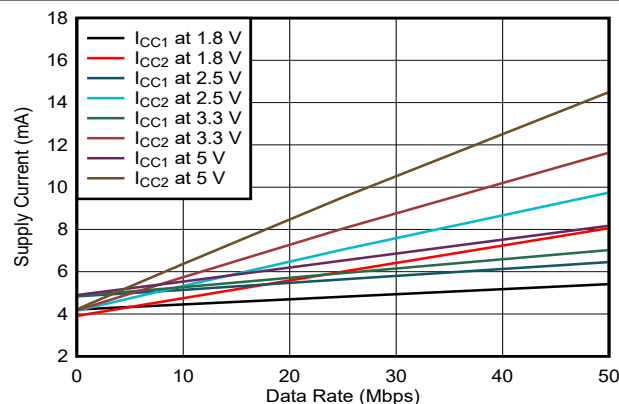


Figure 7-5. ISO6761 Supply Current vs Data Rate (With 15-pF Load)

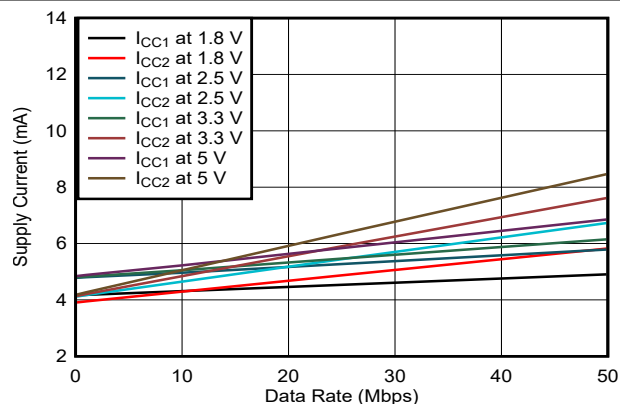


Figure 7-6. ISO6761 Supply Current vs Data Rate (With No Load)

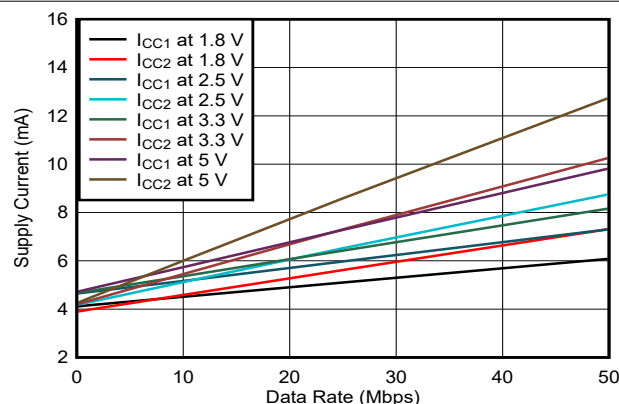


Figure 7-7. ISO6762 Supply Current vs Data Rate (With 15-pF Load)

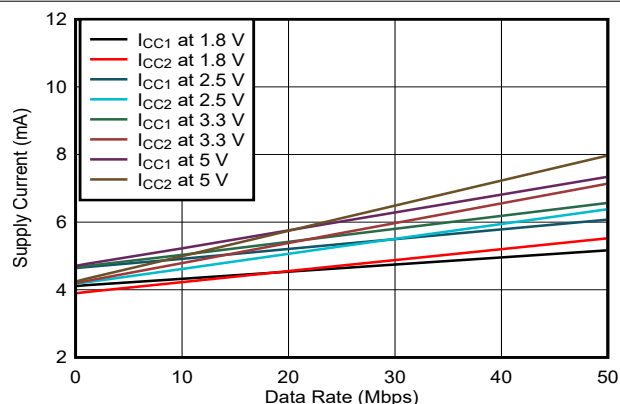


Figure 7-8. ISO6762 Supply Current vs Data Rate (With No Load)

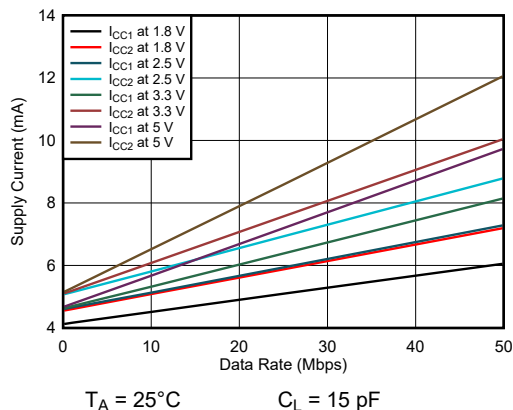


Figure 7-9. ISO6763 Supply Current vs Data Rate (With 15-pF Load)

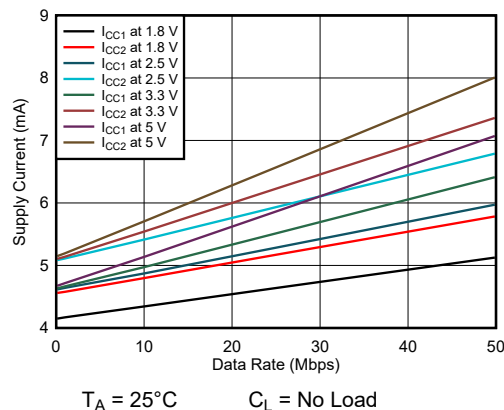


Figure 7-10. ISO6763 Supply Current vs Data Rate (With No Load)

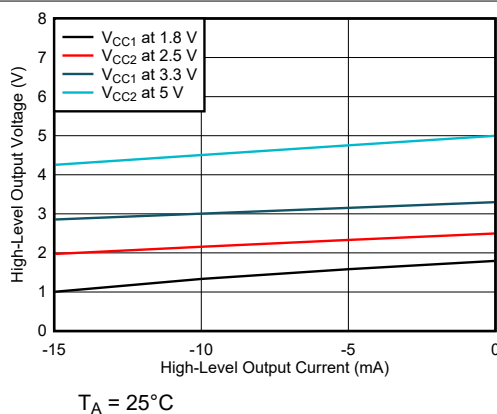


Figure 7-11. High-Level Output Voltage vs High-level Output Current

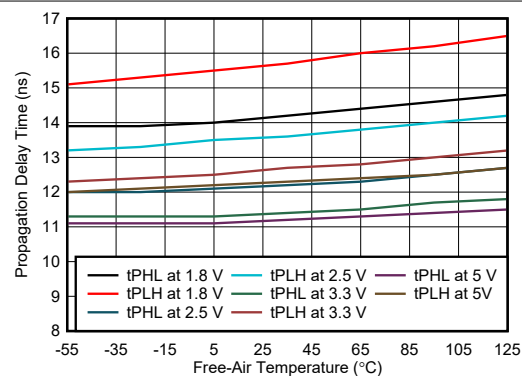


Figure 7-12. Propagation Delay Time vs Free-Air Temperature

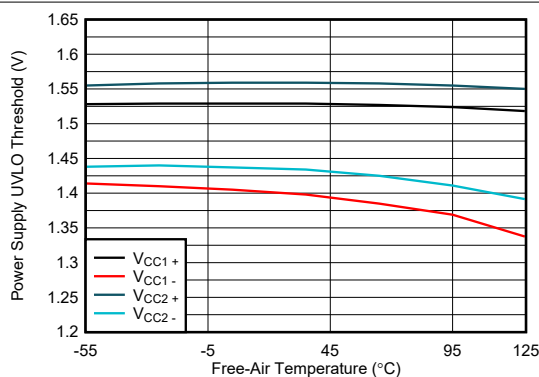


Figure 7-13. Power Supply Undervoltage Threshold vs Free-Air Temperature

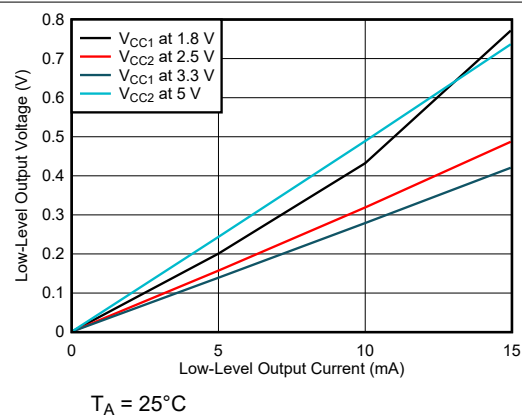
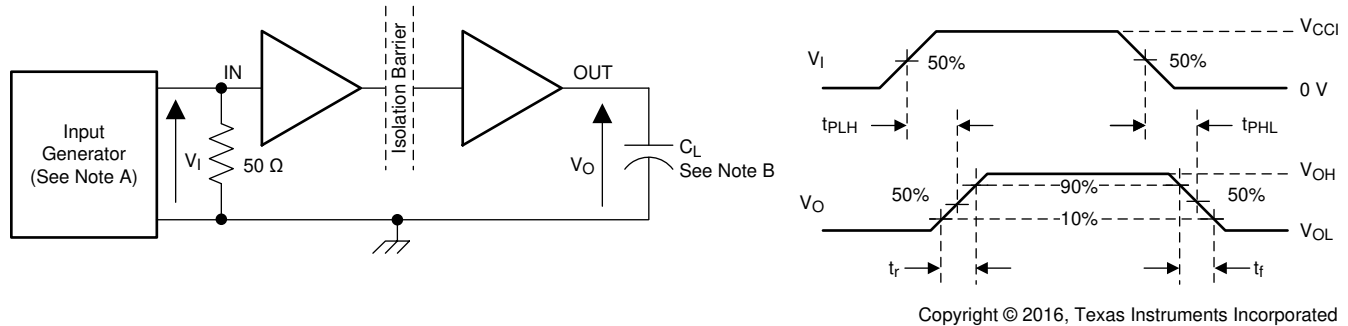


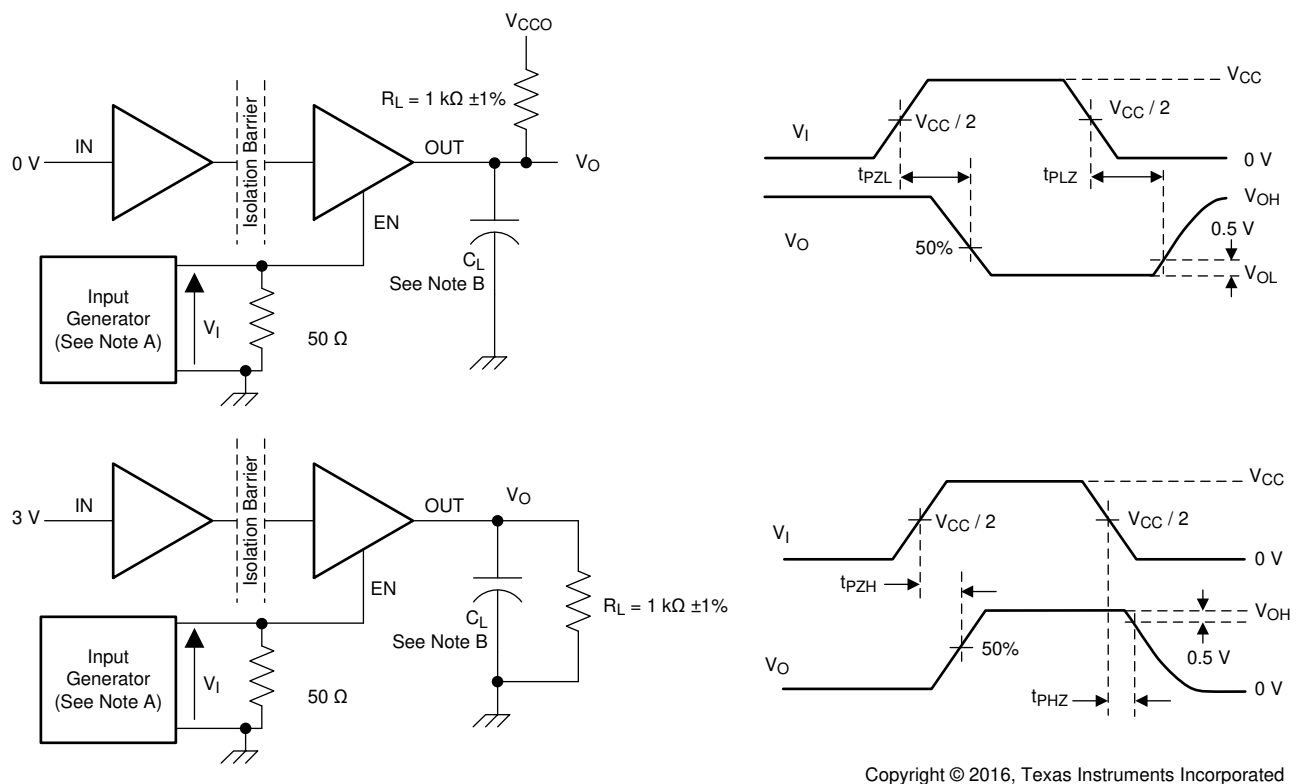
Figure 7-14. Low-Level Output Voltage vs Low-Level Output Current

8 Parameter Measurement Information



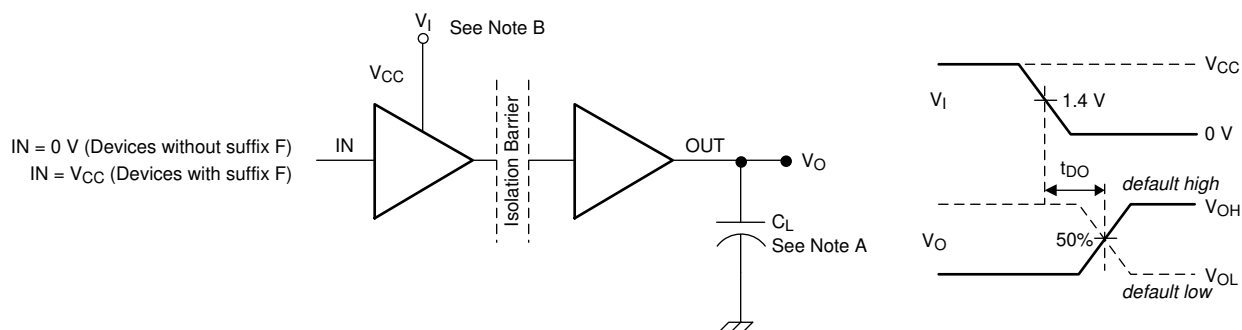
- A. The input pulse is supplied by a generator having the following characteristics: PRR $\leq$ 50 kHz, 50% duty cycle, $t_r \leq 3$ ns, $t_f \leq 3$ ns, $Z_O = 50 \Omega$. At the input, 50Ω resistor is required to terminate Input Generator signal. It is not needed in actual application.
- B. $C_L = 15$ pF and includes instrumentation and fixture capacitance within $\pm 20\%$.

Figure 8-1. Switching Characteristics Test Circuit and Voltage Waveforms



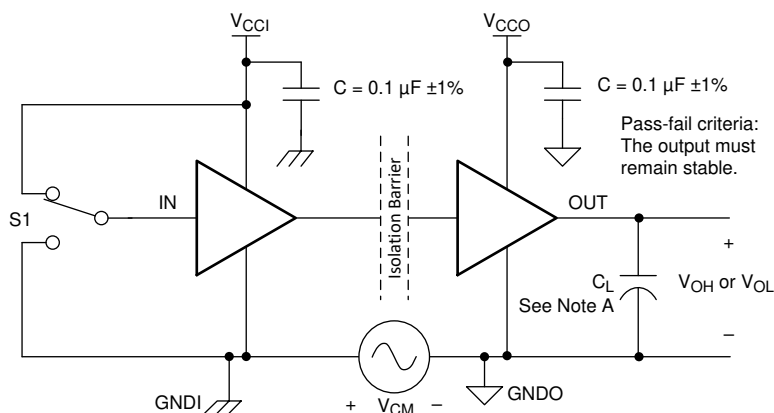
- A. The input pulse is supplied by a generator having the following characteristics: PRR $\leq$ 10 kHz, 50% duty cycle, $t_r \leq 3$ ns, $t_f \leq 3$ ns, $Z_O = 50 \Omega$.
- B. $C_L = 15$ pF and includes instrumentation and fixture capacitance within $\pm 20\%$.

Figure 8-2. Enable/Disable Propagation Delay Time Test Circuit and Waveform



- A. C_L = 15 pF and includes instrumentation and fixture capacitance within ±20%.
- B. Power Supply Ramp Rate = 10 mV/ns

Figure 8-3. Default Output Delay Time Test Circuit and Voltage Waveforms



- A. C_L = 15 pF and includes instrumentation and fixture capacitance within ±20%.

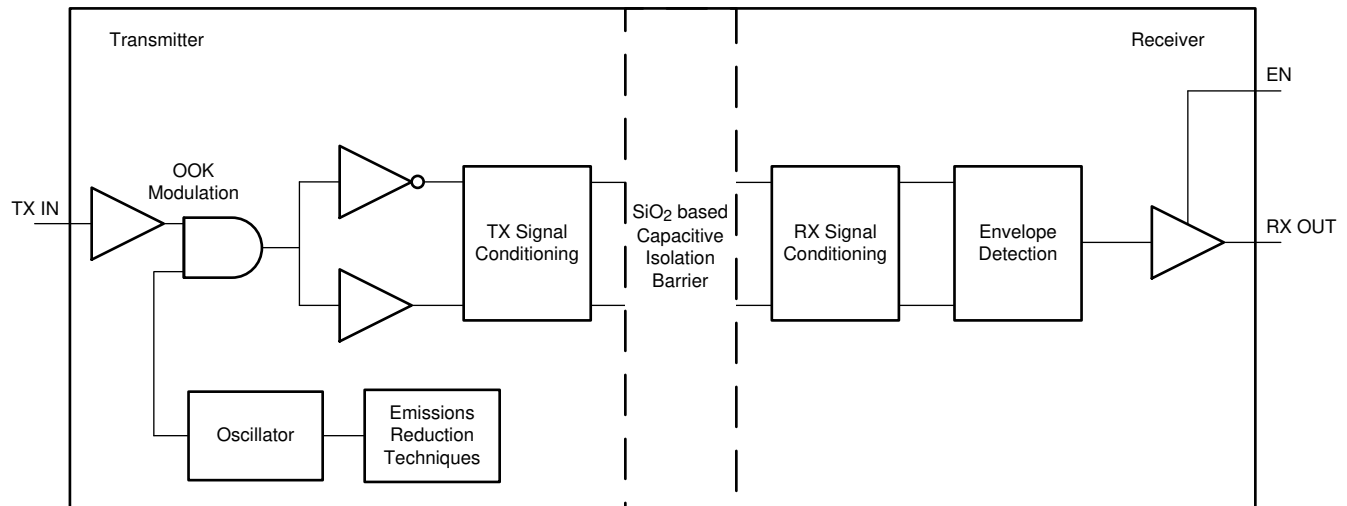
Figure 8-4. Common-Mode Transient Immunity Test Circuit

9 Detailed Description

9.1 Overview

The ISO674x family of devices have an ON-OFF keying (OOK) modulation scheme to transmit the digital data across a silicon dioxide based isolation barrier. The transmitter sends a high frequency carrier across the barrier to represent one digital state and sends no signal to represent the other digital state. The receiver demodulates the signal after advanced signal conditioning and produces the output through a buffer stage. If the ENx pin is low then the output goes to high impedance. The ISO674x devices also incorporate advanced circuit techniques to maximize the CMTI performance and minimize the radiated emissions due to the high frequency carrier and IO buffer switching. The conceptual block diagram of a digital capacitive isolator, [Figure 9-1](#), shows a functional block diagram of a typical channel.

9.2 Functional Block Diagram



Copyright © 2016, Texas Instruments Incorporated

Figure 9-1. Conceptual Block Diagram of a Digital Capacitive Isolator

[Figure 9-2](#) shows a conceptual detail of how the ON-OFF keying scheme works.

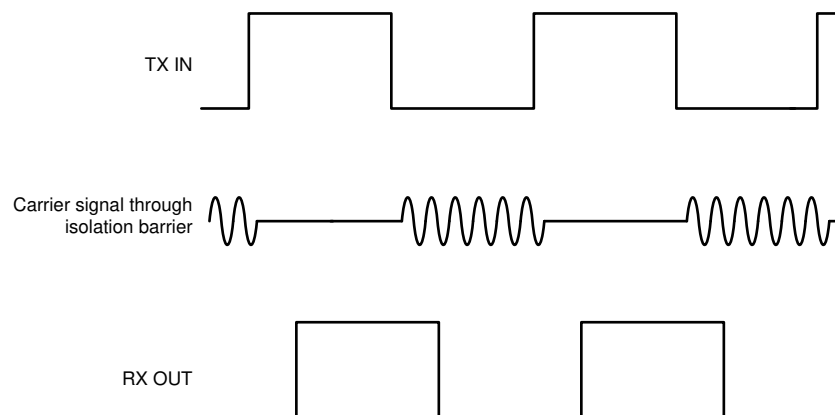


Figure 9-2. On-Off Keying (OOK) Based Modulation Scheme

9.3 Feature Description

Table 9-1 provides an overview of the device features.

Table 9-1. Device Features

PART NUMBER	CHANNEL DIRECTION	MAXIMUM DATA RATE	DEFAULT OUTPUT	PACKAGE	RATED ISOLATION ⁽¹⁾
ISO6740	4 Forward, 0 Reverse	50 Mbps	High	DW-16	5000 V _{RMS} / 8000 V _{PK}
ISO6740F	4 Forward, 0 Reverse	50 Mbps	Low	DW-16	5000 V _{RMS} / 8000 V _{PK}
ISO6741	3 Forward, 1 Reverse	50 Mbps	High	DW-16	5000 V _{RMS} / 8000 V _{PK}
ISO6741F	3 Forward, 1 Reverse	50 Mbps	Low	DW-16	5000 V _{RMS} / 8000 V _{PK}
ISO6742	2 Forward, 2 Reverse	50 Mbps	High	DW-16	5000 V _{RMS} / 8000 V _{PK}
ISO6742F	2 Forward, 2 Reverse	50 Mbps	Low	DW-16	5000 V _{RMS} / 8000 V _{PK}

(1) See [Safety-Related Certifications](#) for detailed isolation ratings.

9.3.1 Electromagnetic Compatibility (EMC) Considerations

Many applications in harsh industrial environment are sensitive to disturbances such as electrostatic discharge (ESD), electrical fast transient (EFT), surge and electromagnetic emissions. These electromagnetic disturbances are regulated by international standards such as IEC 61000-4-x and CISPR 32. Although system-level performance and reliability depends, to a large extent, on the application board design and layout, the ISO674x family of devices incorporates many chip-level design improvements for overall system robustness. Some of these improvements include:

- Robust ESD protection cells for input and output signal pins and inter-chip bond pads.
- Low-resistance connectivity of ESD cells to supply and ground pins.
- Enhanced performance of high voltage isolation capacitor for better tolerance of ESD, EFT and surge events.
- Bigger on-chip decoupling capacitors to bypass undesirable high energy signals through a low impedance path.
- PMOS and NMOS devices isolated from each other by using guard rings to avoid triggering of parasitic SCRs.
- Reduced common mode currents across the isolation barrier by ensuring purely differential internal operation.

9.4 Device Functional Modes

Table 9-2 lists the functional modes for the ISO674x devices.

Table 9-2. Function Table

V_{CCI} ⁽¹⁾	V_{CCO}	INPUT (INx) ⁽³⁾	OUTPUT ENABLE (ENx)	OUTPUT (OUTx)	COMMENTS
PU	PU	H	H or open	H	Normal Operation: A channel output assumes the logic state of its input.
		L	H or open	L	
		Open	H or open	Default	Default mode: When INx is open, the corresponding channel output goes to its default logic state. Default is <i>High</i> for ISO674x and <i>Low</i> for ISO674x with F suffix.
X	PU	X	L	Z	A low value of output enable causes the outputs to be high-impedance.
PD	PU	X	H or open	Default	Default mode: When V_{CCI} is unpowered, a channel output assumes the logic state based on the selected default option. Default is <i>High</i> for ISO674x and <i>Low</i> for ISO674x with F suffix. When V_{CCI} transitions from unpowered to powered-up, a channel output assumes the logic state of the input. When V_{CCI} transitions from powered-up to unpowered, channel output assumes the selected default state.
X	PD	X	X	Undetermined	When V_{CCO} is unpowered, a channel output is undetermined ⁽²⁾ . When V_{CCO} transitions from unpowered to powered-up, a channel output assumes the logic state of the input.

(1) V_{CCI} = Input-side V_{CC} ; V_{CCO} = Output-side V_{CC} ; PU = Powered up ($V_{CC} \geq 1.71$ V); PD = Powered down ($V_{CC} \leq 1.05$ V); X = Irrelevant; H = High level; L = Low level; Z = High Impedance

(2) The outputs are in undetermined state when 1.89 V < V_{CCI} , $V_{CCO} < 2.25$ V and 1.05 V < V_{CCI} , $V_{CCO} < 1.71$ V

(3) A strongly driven input signal can weakly power the floating V_{CC} through an internal protection diode and cause undetermined output

9.4.1 Device I/O Schematics

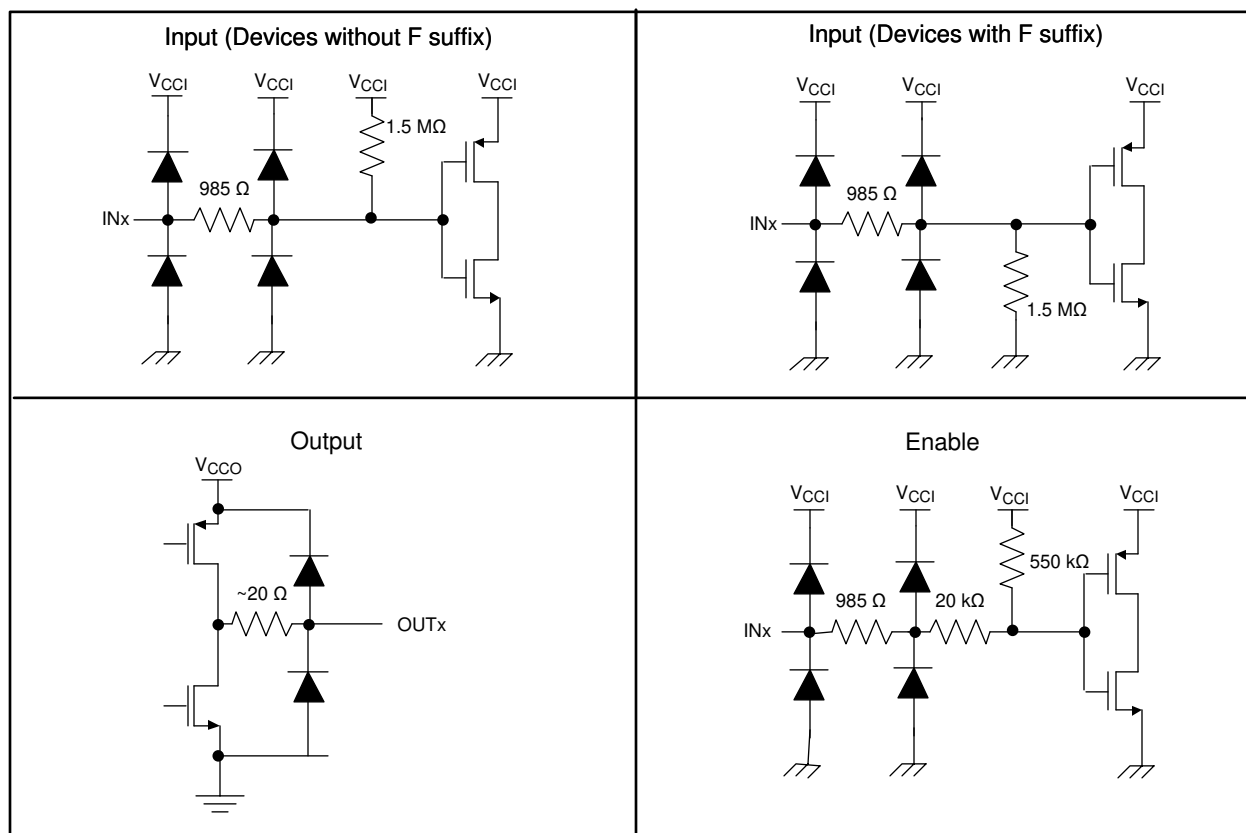


Figure 9-3. Device I/O Schematics

10 Application and Implementation

Note

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

10.1 Application Information

The ISO674x devices are high-performance, quad-channel digital isolators. These devices come with enable pins on each side which can be used to put the respective outputs in high impedance for multi master driving applications. The ISO674x devices use single-ended CMOS-logic switching technology. The supply voltage range is from 1.71 V to 5.5 V for both supplies, V_{CC1} and V_{CC2} . Since an isolation barrier separates the two sides, each side can be sourced independently with any voltage within recommended operating conditions. As an example, it is possible to supply ISO674x V_{CC1} with 3.3 V (which is within 1.71 V to 5.5 V) and V_{CC2} with 5V (which is also within 1.71 V to 5.5 V). You can use the digital isolator as a logic-level translator in addition to providing isolation. When designing with digital isolators, keep in mind that because of the single-ended design structure, digital isolators do not conform to any specific interface standard and are only intended for isolating single-ended CMOS or TTL digital signal lines. The isolator is typically placed between the data controller (that is, MCU or FPGA), and a data converter or a line transceiver, regardless of the interface type or standard.

10.2 Typical Application

Figure 10-1 shows the isolated serial peripheral interface (SPI).

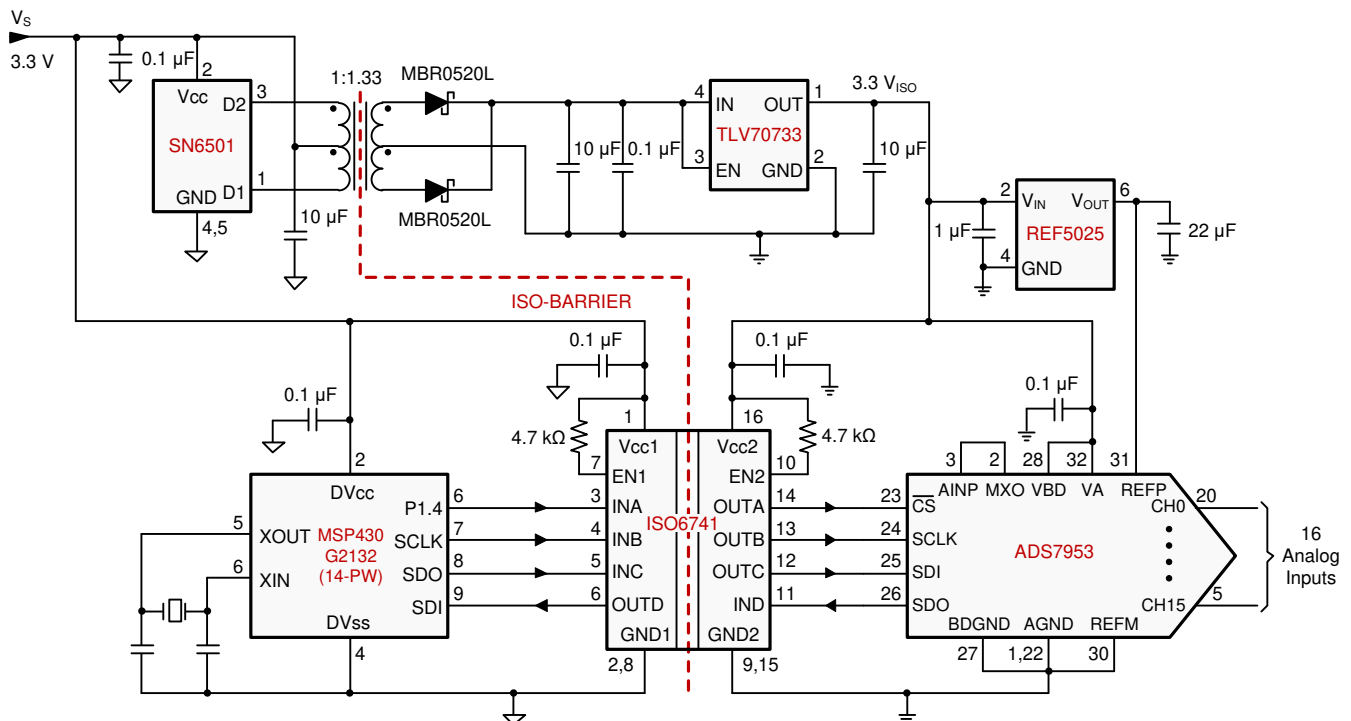


Figure 10-1. Isolated SPI for an Analog Input Module With 16 Inputs

10.2.1 Design Requirements

To design with these devices, use the parameters listed in [Table 10-1](#).

Table 10-1. Design Parameters

PARAMETER	VALUE
Supply voltage, V_{CC1} and V_{CC2}	1.71 V to 1.89 V and 2.25 V to 5.5 V
Decoupling capacitor between V_{CC1} and GND1	0.1 μ F
Decoupling capacitor from V_{CC2} and GND2	0.1 μ F

10.2.2 Detailed Design Procedure

Unlike optocouplers, which require external components to improve performance, provide bias, or limit current, the ISO674x family of devices only require two external bypass capacitors to operate.

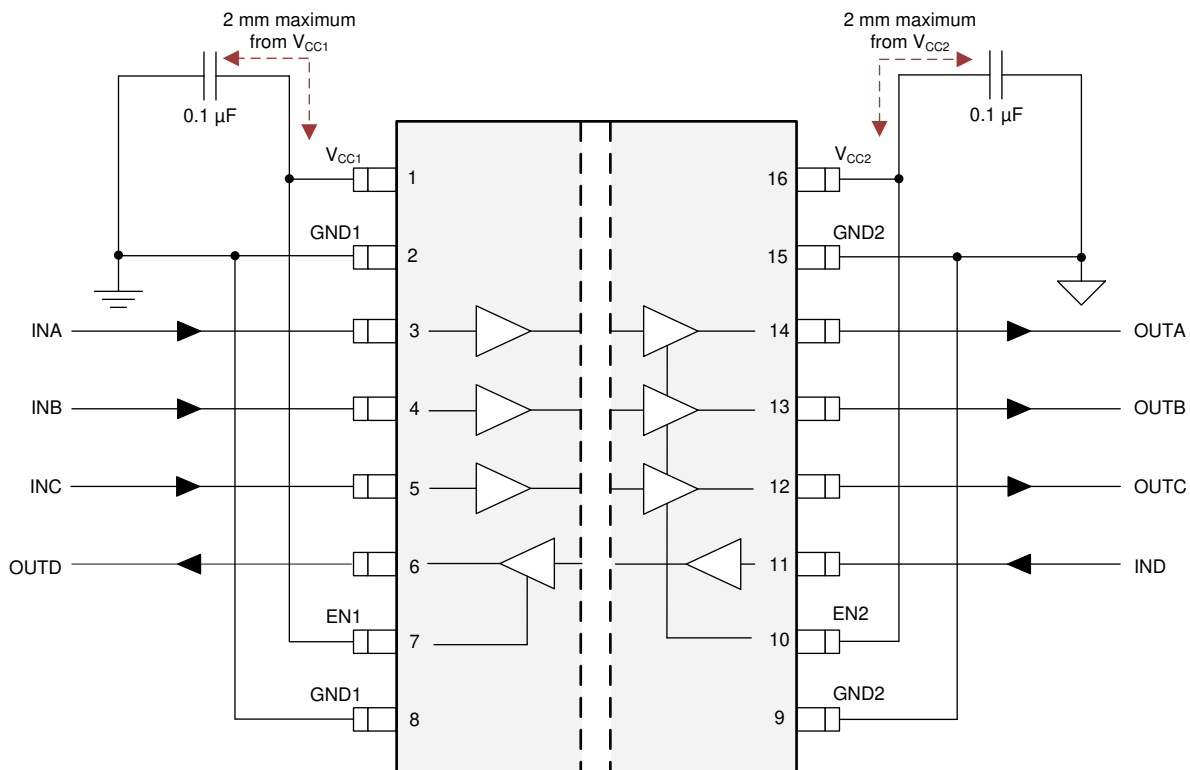


Figure 10-2. Typical ISO674x Circuit Hook-up

10.2.3 Application Curve

The following typical eye diagrams of the ISO674x family of devices indicates low jitter and wide open eye at the maximum data rate of 50 Mbps.

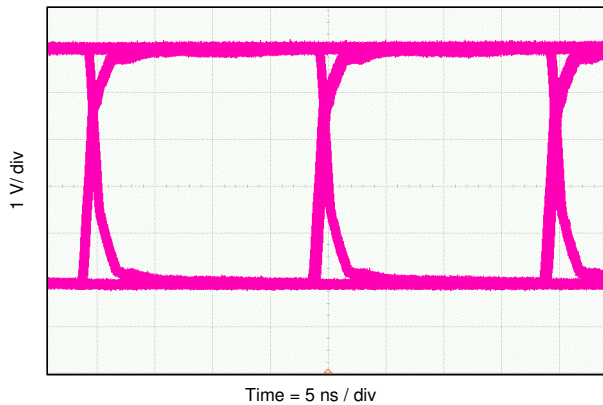


Figure 10-3. Eye Diagram at 50 Mbps PRBS $2^{16} - 1$, 5 V and 25°C

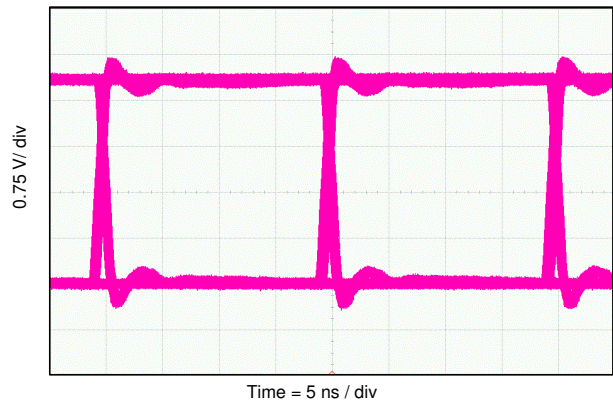


Figure 10-4. Eye Diagram at 50 Mbps PRBS $2^{16} - 1$, 3.3 V and 25°C

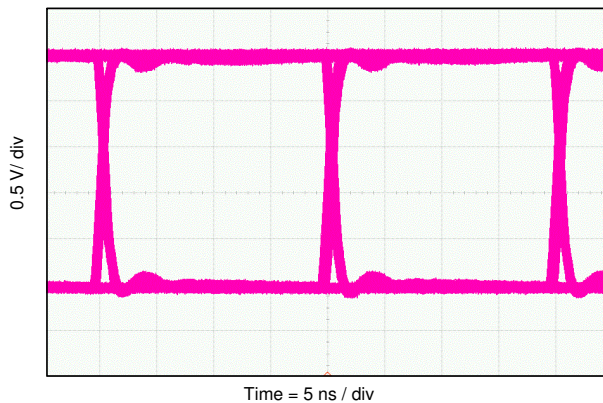


Figure 10-5. Eye Diagram at 50 Mbps PRBS $2^{16} - 1$, 2.5 V and 25°C

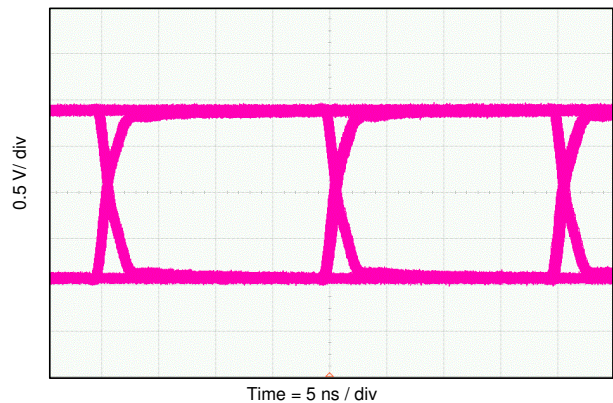


Figure 10-6. Eye Diagram at 50 Mbps PRBS $2^{16} - 1$, 1.8 V and 25°C

10.2.3.1 Insulation Lifetime

Insulation lifetime projection data is collected by using industry-standard Time Dependent Dielectric Breakdown (TDDB) test method. In this test, all pins on each side of the barrier are tied together creating a two-terminal device and high voltage applied between the two sides; See [Figure 10-7](#) for TDDB test setup. The insulation breakdown data is collected at various high voltages switching at 60 Hz over temperature. For reinforced insulation, VDE standard requires the use of TDDB projection line with failure rate of less than 1 part per million (ppm). Even though the expected minimum insulation lifetime is 20 years at the specified working isolation voltage, VDE reinforced certification requires additional safety margin of 20% for working voltage and 87.5% for lifetime which translates into minimum required insulation lifetime of 37.5 years at a working voltage that's 20% higher than the specified value.

[Figure 10-8](#) shows the intrinsic capability of the isolation barrier to withstand high voltage stress over its lifetime. Based on the TDDB data, the intrinsic capability of the insulation is 1500 V_{RMS} with a lifetime of 135 years. Other factors, such as package size, pollution degree, material group, etc. can further limit the working voltage of the component. The working voltage of DW-16 package is specified upto 1500 V_{RMS}. At the lower working voltages, the corresponding insulation lifetime is much longer than 135 years.

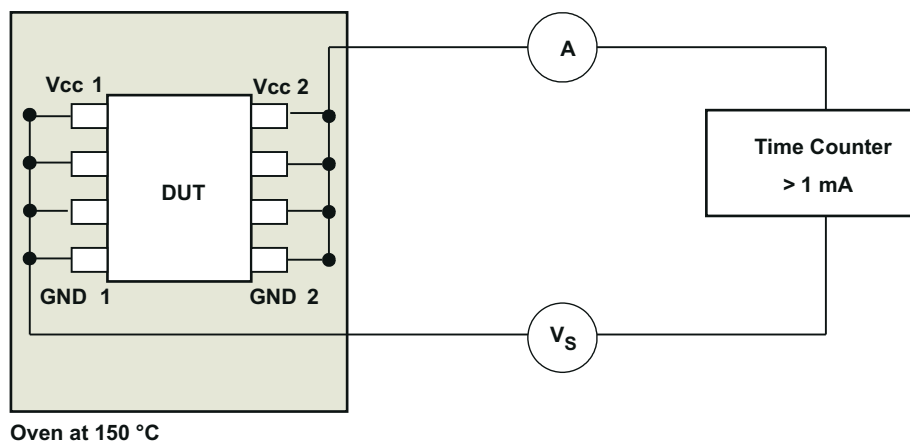


Figure 10-7. Test Setup for Insulation Lifetime Measurement

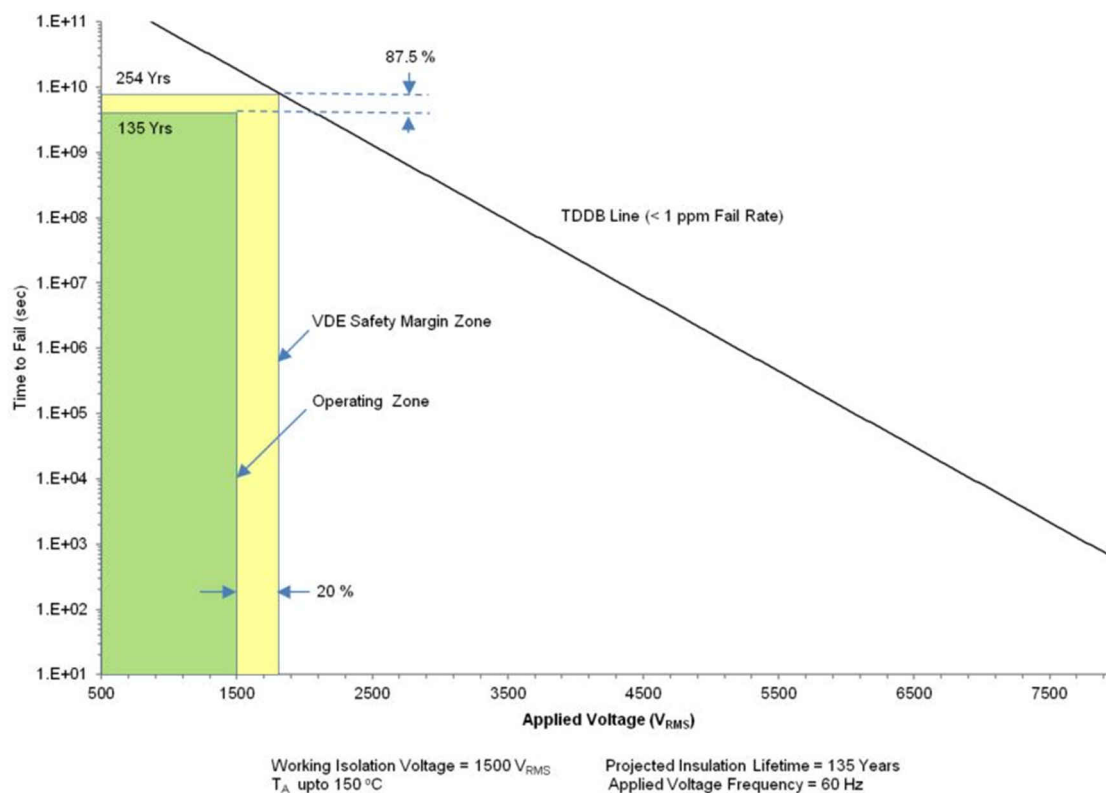


Figure 10-8. Insulation Lifetime Projection Data

11 Power Supply Recommendations

To help ensure reliable operation at data rates and supply voltages, a 0.1- μ F bypass capacitor is recommended at the input and output supply pins (V_{CC1} and V_{CC2}). The capacitors should be placed as close to the supply pins as possible. If only a single primary-side power supply is available in an application, isolated power can be generated for the secondary-side with the help of a transformer driver. For industrial applications, please use Texas Instruments' [SN6501](#) or [SN6505B](#). For such applications, detailed power supply design and transformer selection recommendations are available in [SN6501 Transformer Driver for Isolated Power Supplies](#) or [SN6505B-Q1 Low-noise, 1-A Transformer Drivers for Isolated Power Supplies](#).

12 Layout

12.1 Layout Guidelines

A minimum of two layers is required to accomplish a cost optimized and low EMI PCB design. To further improve EMI, a four layer board can be used (see [Figure 12-2](#)). Layer stacking for a four layer board should be in the following order (top-to-bottom): high-speed signal layer, ground plane, power plane and low-frequency signal layer.

- Routing the high-speed traces on the top layer avoids the use of vias (and the introduction of their inductances) and allows for clean interconnects between the isolator and the transmitter and receiver circuits of the data link.
- Placing a solid ground plane next to the high-speed signal layer establishes controlled impedance for transmission line interconnects and provides an excellent low-inductance path for the return current flow.
- Placing the power plane next to the ground plane creates additional high-frequency bypass capacitance of approximately 100 pF/inch².
- Routing the slower speed control signals on the bottom layer allows for greater flexibility as these signal links usually have margin to tolerate discontinuities such as vias.

If an additional supply voltage plane or signal layer is needed, add a second power or ground plane system to the stack to keep it symmetrical. This makes the stack mechanically stable and prevents it from warping. Also the power and ground plane of each power system can be placed closer together, thus increasing the high-frequency bypass capacitance significantly.

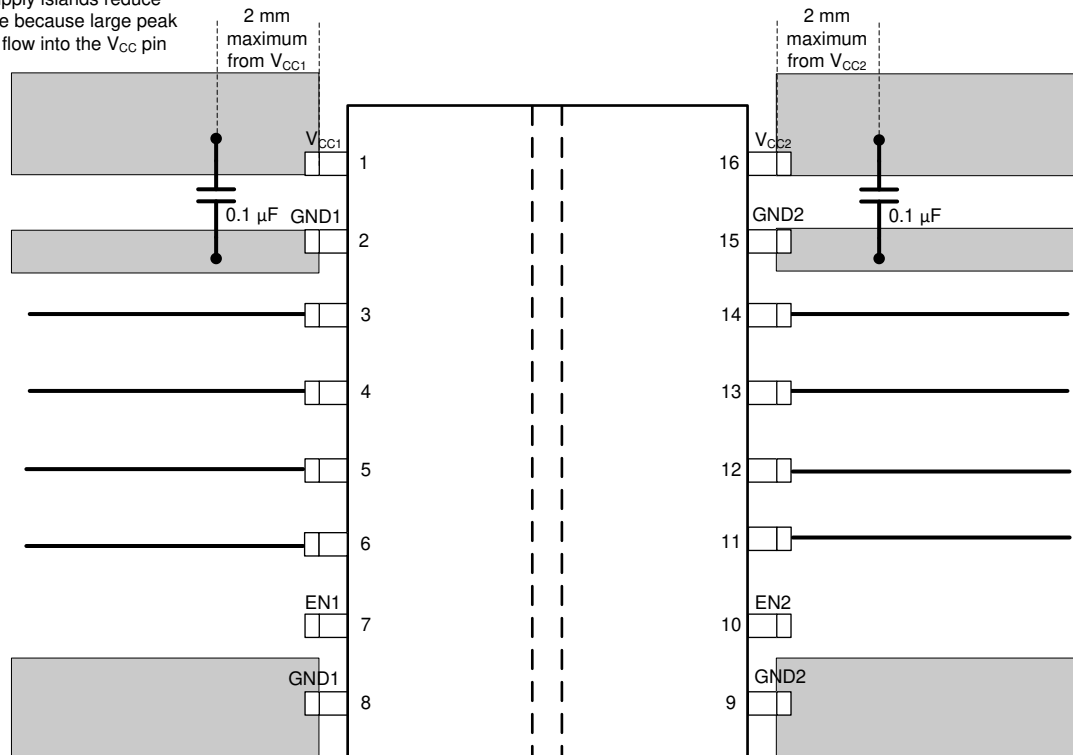
For detailed layout recommendations, refer to the [Digital Isolator Design Guide](#).

12.1.1 PCB Material

For digital circuit boards operating below 150 Mbps, (or rise and fall times higher than 1 ns), and trace lengths of up to 10 inches, use standard FR-4 UL94V-0 printed circuit boards. This PCB is preferred over cheaper alternatives due to its lower dielectric losses at high frequencies, less moisture absorption, greater strength and stiffness, and self-extinguishing flammability-characteristics.

12.2 Layout Example

Solid supply islands reduce inductance because large peak currents flow into the V_{CC} pin



Solid ground islands help dissipate heat through PCB

Figure 12-1. Layout Example

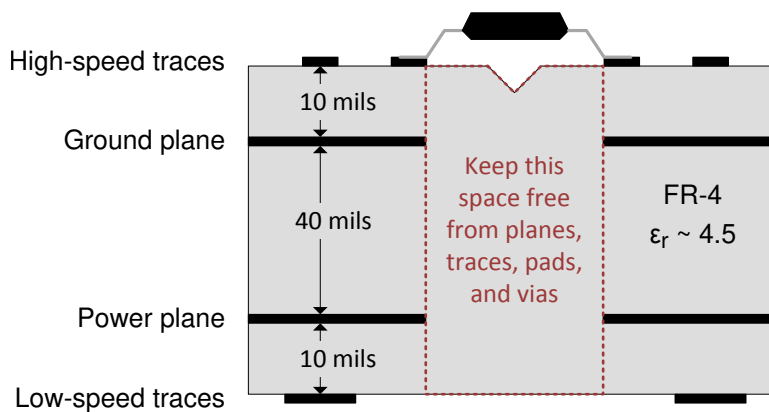


Figure 12-2. Layout Example Schematic

13 Device and Documentation Support

13.1 Documentation Support

13.1.1 Related Documentation

For related documentation, see the following:

- Texas Instruments, [Digital Isolator Design Guide](#)
- Texas Instruments, [Digital Isolator Design Guide](#)
- Texas Instruments, [Isolation Glossary](#)
- Texas Instruments, [How to use isolation to improve ESD, EFT, and Surge immunity in industrial systems application report](#)
- Texas Instruments, [ADS79xx 12/10/8-Bit, 1 MSPS, 16/12/8/4-Channel, Single-Ended, MicroPower, Serial Interface ADCs data sheet](#)
- Texas Instruments, [DAC161P997 Single-Wire 16-bit DAC for 4- to 20-mA Loops data sheet](#)
- Texas Instruments, [MSP430G2132Mixed Signal Microcontroller data sheet](#)
- Texas Instruments, [SN6501 Transformer Driver for Isolated Power Supplies data sheet](#)
- Texas Instruments, [TPS76333Low-Power 150-mA Low-Dropout Linear Regulators data sheet](#)

13.2 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. In the upper right corner, click on *Alert me* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

13.3 Support Resources

TI E2E™ support forums are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

Linked content is provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's [Terms of Use](#).

13.4 Trademarks

TI E2E™ is a trademark of Texas Instruments.

All trademarks are the property of their respective owners.

13.5 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

13.6 Glossary

TI Glossary This glossary lists and explains terms, acronyms, and definitions.

14 Mechanical, Packaging, and Orderable Information

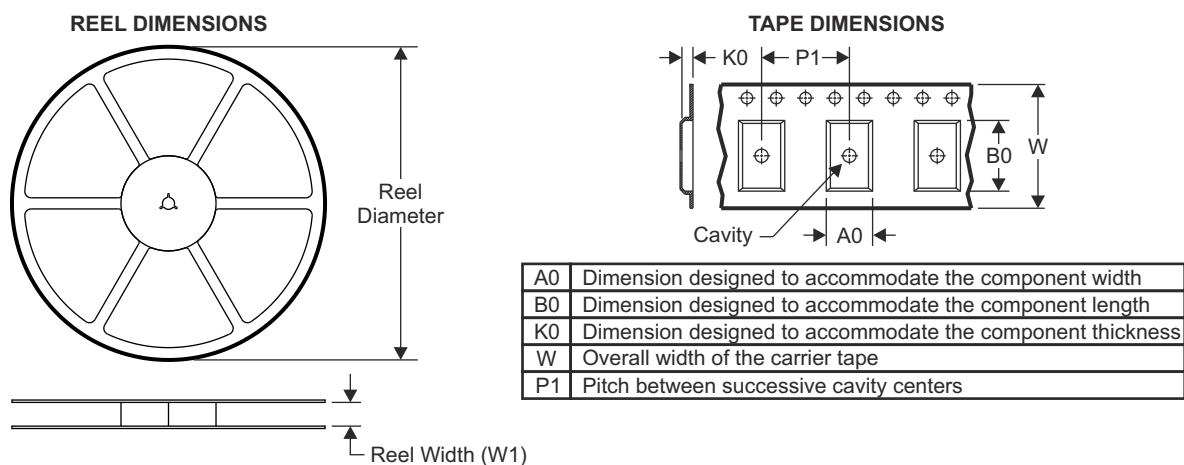
The following pages include mechanical packaging and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

14.1 Package Option Addendum

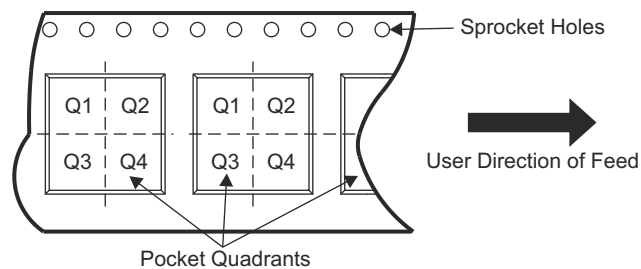
Packaging Information

Orderable Device	Status ⁽¹⁾	Package Type	Package Drawing	Pins	Package Qty	Eco Plan ⁽²⁾	Lead/Ball Finish ⁽⁶⁾	MSL Peak Temp ⁽³⁾	Op Temp (°C)	Device Marking ^{(4) (5)}
ISO6740DWR	ACTIVE	SOIC	DW	16	2000	Green (RoHS & no Sb/Br)	NIPDAU	Level-2-260C-1 YEAR	--40 to 125	ISO6740
ISO6740FDWR	ACTIVE	SOIC	DW	16	2000	Green (RoHS & no Sb/Br)	NIPDAU	Level-2-260C-1 YEAR	--40 to 125	ISO6740F
ISO6741DWR	ACTIVE	SOIC	DW	16	2000	Green (RoHS & no Sb/Br)	NIPDAU	Level-2-260C-1 YEAR	--40 to 125	ISO6741
ISO6741FDWR	ACTIVE	SOIC	DW	16	2000	Green (RoHS & no Sb/Br)	NIPDAU	Level-2-260C-1 YEAR	--40 to 125	ISO6741F
ISO6742DWR	ACTIVE	SOIC	DW	16	2000	Green (RoHS & no Sb/Br)	NIPDAU	Level-2-260C-1 YEAR	--40 to 125	ISO6742
ISO6742FDWR	ACTIVE	SOIC	DW	16	2000	Green (RoHS & no Sb/Br)	NIPDAU	Level-2-260C-1 YEAR	--40 to 125	ISO6742F

14.2 Tape and Reel Information

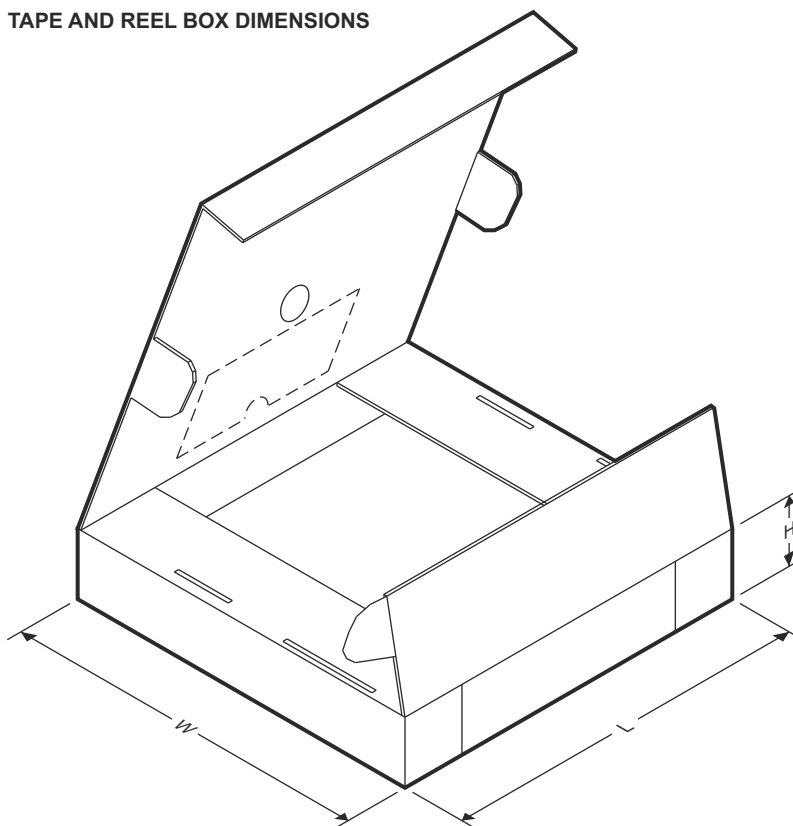


QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
ISO6740DWR	SOIC	DW	16	2000	330.0	24.4	10.9	10.7	2.7	12.0	24.0	Q1
ISO6740FDWR	SOIC	DW	16	2000	330.0	24.4	10.9	10.7	2.7	12.0	24.0	Q1
ISO6741DWR	SOIC	DW	16	2000	330.0	24.4	10.9	10.7	2.7	12.0	24.0	Q1
ISO6741FDWR	SOIC	DW	16	2000	330.0	24.4	10.9	10.7	2.7	12.0	24.0	Q1
ISO6742DWR	SOIC	DW	16	2000	330.0	24.4	10.9	10.7	2.7	12.0	24.0	Q1
ISO6742FDWR	SOIC	DW	16	2000	330.0	24.4	10.9	10.7	2.7	12.0	24.0	Q1

TAPE AND REEL BOX DIMENSIONS



Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
ISO6740DWR	SOIC	DW	16	2000	367.0	367.0	45.0
ISO6740FDWR	SOIC	DW	16	2000	367.0	367.0	45.0
ISO6741DWR	SOIC	DW	16	2000	367.0	367.0	45.0
ISO6741FDWR	SOIC	DW	16	2000	367.0	367.0	45.0
ISO6742DWR	SOIC	DW	16	2000	367.0	367.0	45.0
ISO6742FDWR	SOIC	DW	16	2000	367.0	367.0	45.0

GENERIC PACKAGE VIEW

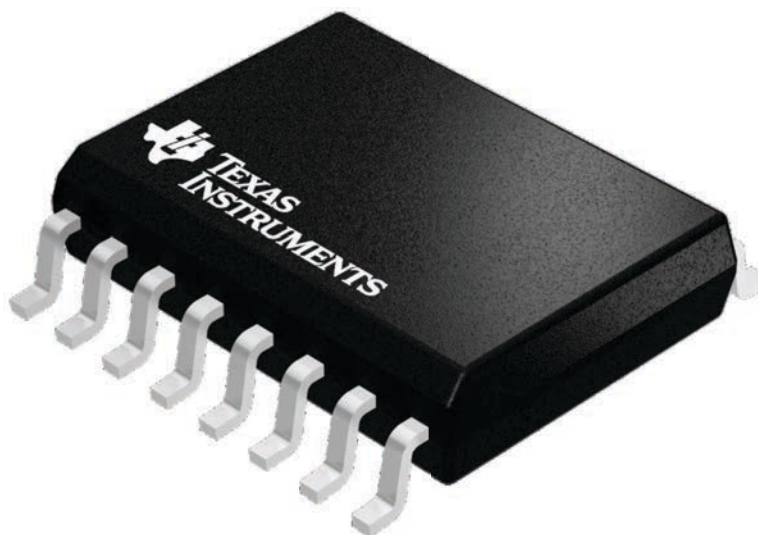
DW 16

SOIC - 2.65 mm max height

7.5 x 10.3, 1.27 mm pitch

SMALL OUTLINE INTEGRATED CIRCUIT

This image is a representation of the package family, actual package may vary.
Refer to the product data sheet for package details.



4224780/A

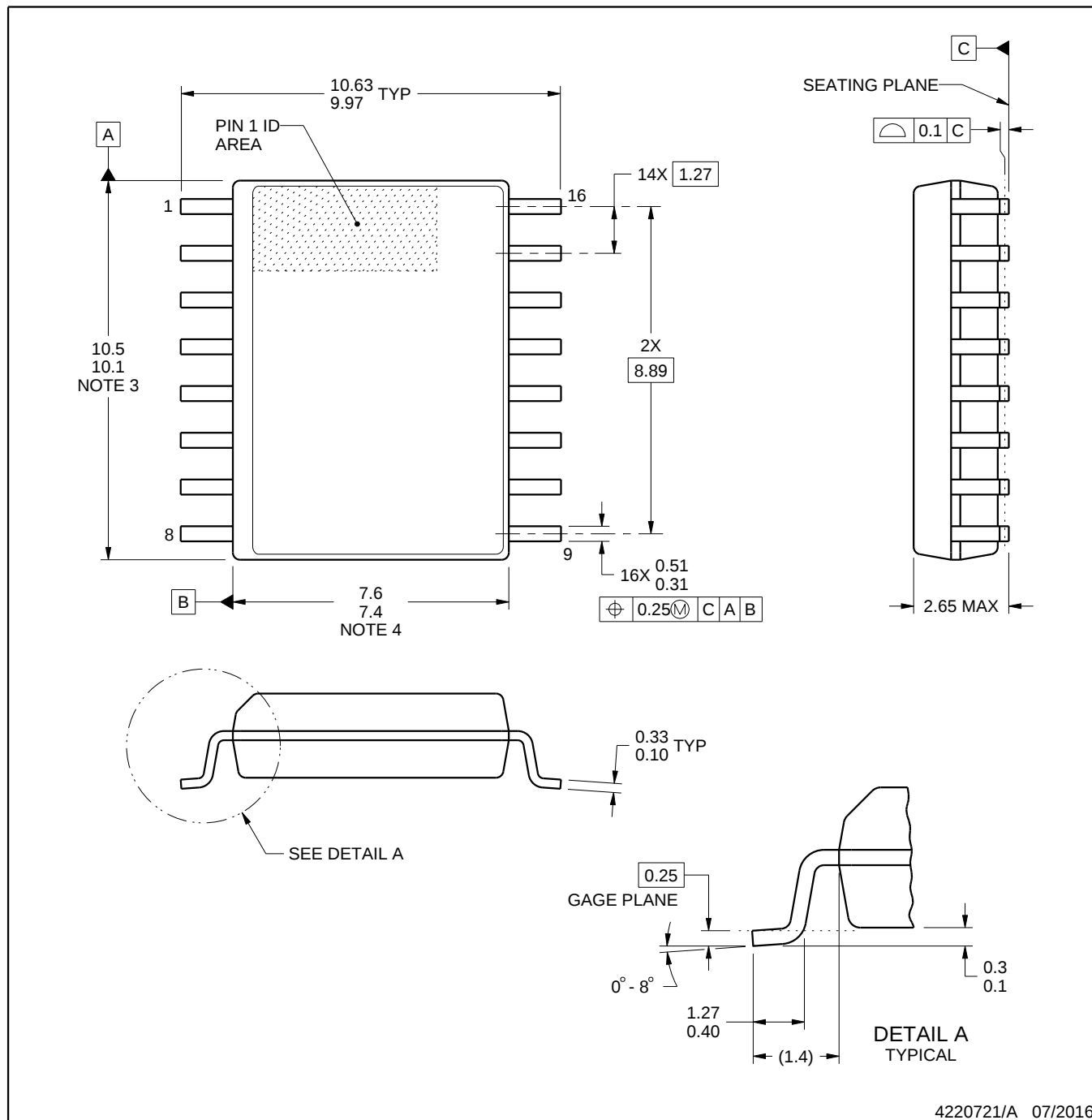


DW0016A

PACKAGE OUTLINE

SOIC - 2.65 mm max height

SOIC



4220721/A 07/2016

NOTES:

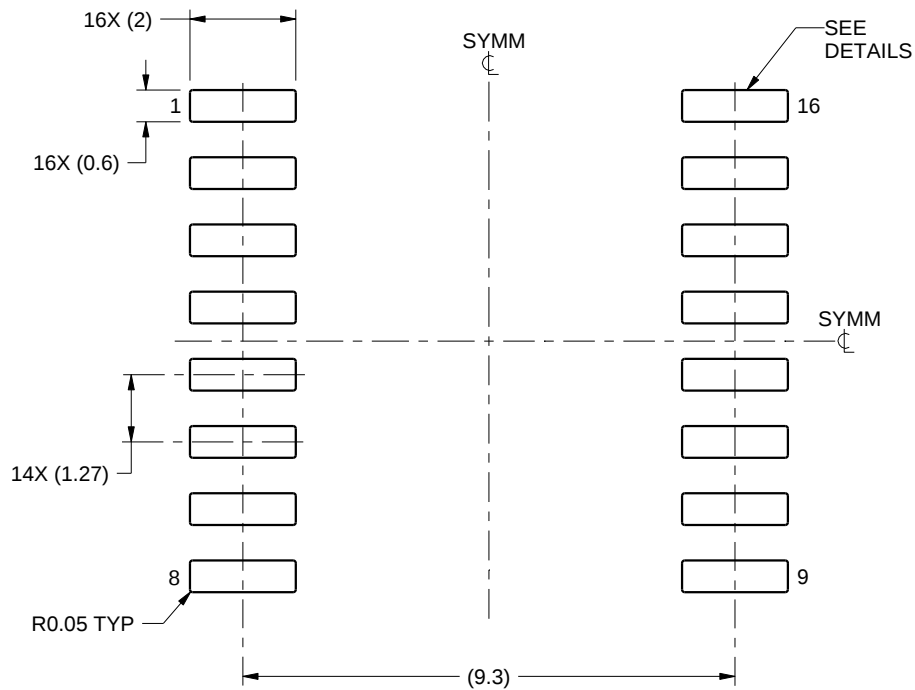
1. All linear dimensions are in millimeters. Dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm, per side.
4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm, per side.
5. Reference JEDEC registration MS-013.

EXAMPLE BOARD LAYOUT

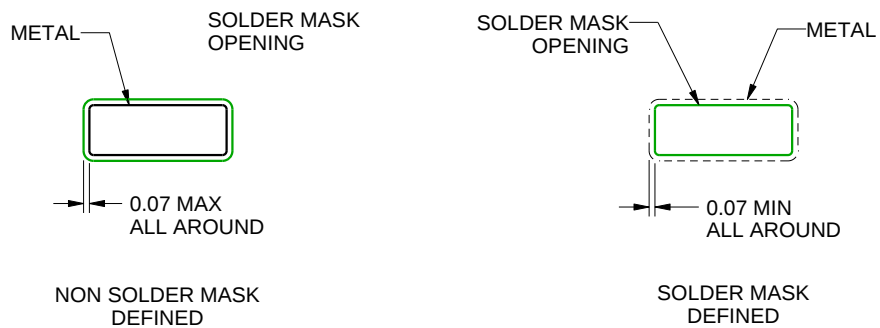
DW0016A

SOIC - 2.65 mm max height

SOIC



LAND PATTERN EXAMPLE
SCALE:7X



SOLDER MASK DETAILS

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NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

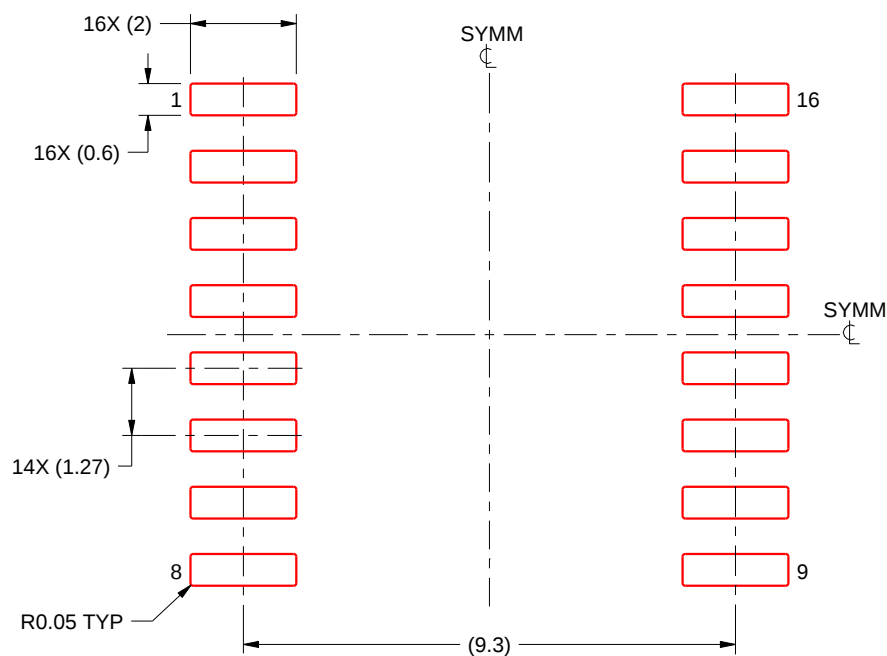
7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

EXAMPLE STENCIL DESIGN

DW0016A

SOIC - 2.65 mm max height

SOIC



SOLDER PASTE EXAMPLE
BASED ON 0.125 mm THICK STENCIL
SCALE:7X

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NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
9. Board assembly site may have different recommendations for stencil design.

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